

GD25LX512ME

DATASHEET



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### 1. FEATURES

- 512M-bit Serial Flash
  - 64M-byte
  - 256 bytes per programmable page
- · Standard, Octal SPI, DTR Octal SPI
- Standard SPI: SCLK, CS#, SI, SO, IO[7:2], WP#, RESET#
- Octal SPI: SCLK, CS#, IO[7:0], WP#, RESET#
- OPI DTR (Double Transfer Rate) Read
- 3- or 4-Byte Address Mode
- · High Speed Clock Frequency
  - 200MHz for fast read with 30PF load
  - OPI Mode Data transfer up to 166MBytes/s
  - Octal I/O Data transfer up to 166MBytes/s
  - DTR Octal I/O Data transfer up to 400MBytes/s with DQS
- · Allows XIP(execute in place)operation
  - Continuous Read With 16/32/64-byte Wrap
- Software/Hardware Write Protection
  - Write protect all/portion of memory via software
  - Enable/Disable protection with WP# Pin
  - Advanced Sector Protection
  - -Top or Bottom selection
- Data Integrity Check
  - On-chip ECC (1-bit correction every 8-Byte) (1)
  - CRC detects accidental changes to raw data

- Fast Program/Erase Speed
  - Page Program time: 0.15ms typical
  - Sector Erase time: 30ms typical
  - Block Erase time: 0.2/0.22s typical
  - Chip Erase time: 150s typical
- Flexible Architecture
  - Sector of 4K-Byte
  - Block of 32/64K-Byte
  - Erase/Program Suspend/Resume
- Low Power Consumption
  - 20uA typical stand-by current
  - 3uA typical power-down current
- Advanced Security Features
  - 128-bit Unique ID
  - 4K-Byte Security Registers With OTP Lock
- Single Power Supply Voltage
  - Full voltage range: 1.65~2.0V
- Data retention
  - 20-year data retention typical
- Minimum 100,000 Program/Erase Cycles

### Note:

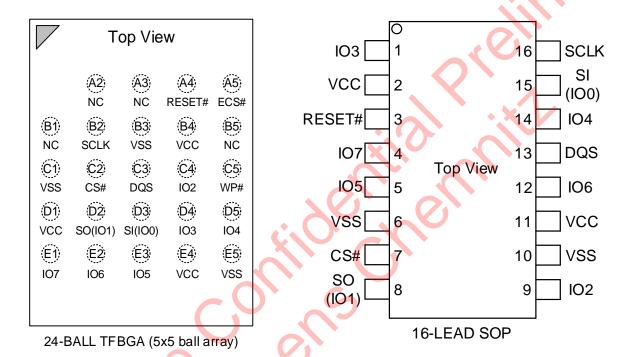
 When ECC is enabled, it is required to program minimum one or multiple aligned 8-Byte granularities. Every aligned 8-Byte granularity should only be programmed once before Erase to ensure correct ECC operations.



### 2. GENERAL DESCRIPTION

The GD25LX512ME (512M-bit) Serial flash supports the standard Serial Peripheral Interface (SPI), and supports the Octal SPI and DTR mode: Serial Clock, Chip Select, Serial Data I/O0 (SI), I/O1 (SO), I/O2, I/O3, I/O4, I/O5, I/O6, I/O7, RESET#, WP# and DQS. The Octal I/O & Octal output data is transferred with speed of 166MBytes/s, and the DTR Octal I/O data is transferred with speed of 400MBytes/s.

### **CONNECTION DIAGRAM**



Note: CS# must be driven high if chip is not selected. Please don't leave CS# floating any time after power is on.

### PIN DESCRIPTION

Table 1. Ball Description for TFBGA24 (5x5 ball array) package

Pin No.	Pin Name	1/0	Description
A4	RESET#	I	Reset Input
A5	ECS#	0	ECC Correction Signal
B2	SCLK	I	Serial Clock Input
B3/C1/E5	VSS		Ground
B4/D1/E4	VCC		Power Supply
C2	CS#	I	Chip Select Input
С3	DQS	0	Data Strobe Signal Output
C4	IO2	I/O	Data Input Output 2
C5	WP#	I	Write Protect Input





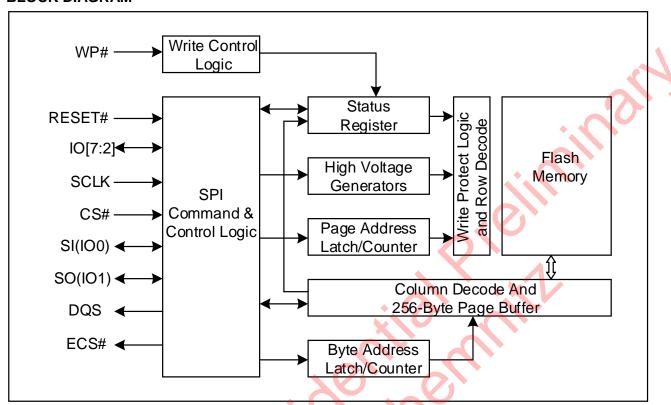
			_
D2	SO (IO1)	I/O	Data Output (Data Input Output 1)
D3	SI (IO0)	I/O	Data Input (Data Input Output 0)
D4	IO3	I/O	Data Input Output 3
D5	IO4	I/O	Data Input Output 4
E1	107	I/O	Data Input Output 7
E2	IO6	I/O	Data Input Output 6
E3	IO5	I/O	Data Input Output 5

Table 2. Pin Description for SOP16 300mil package

Pin No.	Pin Name	1/0	Description
1	IO3	I/O	Data Input Output 3
2	VCC		Power Supply
3	RESET#	I	Reset Input
4	107	I/O	Data Input Output 7
5	IO5	I/O	Data Input Output 5
6	VSS		Ground
7	CS#	I	Chip Select Input
8	SO (IO1)	I/O	Data Output (Data Input Output 1)
9	IO2	I/O	Data Input Output 2
10	VSS	CAU	Ground
11	VCC		Power Supply
12	IO6	1/0	Data Input Output 6
13	DQS	0	Data Strobe Signal Output
14	IO4	I/O	Data Input Output 4
15	SI (IO0)	I/O	Data Input (Data Input Output 0)
16	SCLK		Serial Clock Input



### **BLOCK DIAGRAM**





### 3. MEMORY ORGANIZATION

### GD25LX512ME

Each device has	Each block has	Each sector has	Each page has	
64M	64/32K	4K	256	Bytes
256K	256/128	16	-	pages
16K	16/8	-	-	sectors
1K/2K	-	-	-	blocks

# UNIFORM BLOCK SECTOR ARCHITECTURE GD25LX512ME 64K Bytes Block Sector Architecture

Block	Sector	Addres	ss range
	16383	3FFF000h	3FFFFFFh
1023			• V
	16368	3FF0000h	3FF0FFFh
	16367	3FEF000h	3FEFFFFh
1022			
	16352	3FE0000h	3FE0FFFh
		<u>G</u>	
	47	02F000h	02FFFFh
2			
	32	020000h	020FFFh
	31	01F000h	01FFFFh
	16	010000h	010FFFh
$\mathcal{N}_{\mathbf{A}}$	15	00F000h	00FFFFh
0			
	0	000000h	000FFFh



### 4. DEVICE OPERATION

### 4.1. SPI Mode

#### Standard SPI

The GD25LX512ME features a serial peripheral interface on 4 signals bus: Serial Clock (SCLK), Chip Select (CS#), Serial Data Input (SI) and Serial Data Output (SO). Both SPI bus mode 0 and 3 are supported. Input data is latched on the rising edge of SCLK and data shifts out on the falling edge of SCLK.

#### **Octal SPI**

The GD25LX512ME supports Octal SPI operation when using the "Octal Output Fast Read", "Octal I/O Fast Read", "Octal Input Page Program, Extended Octal Input Fast Program" (8BH/7CH, CBH/CCH, 82H/84H,C2H/8EH) commands. These commands allow data to be transferred to or from the device at eight times the rate of the standard SPI. When using the Octal SPI command the SI and SO pins become bidirectional I/O pins: IO0 and IO1.

### **Octal DTR SPI**

The GD25LX512ME supports DTR Octal SPI operation when using the "DTR Octal I/O Fast Read" (FDH) command. This command allows data to be transferred to or from the device at sixteen times the rate of the standard SPI, and data output will be latched on both rising and falling edges of the serial clock. When using the DTR Octal SPI command the SI and SO pins become bidirectional I/O pins: IOO and IO1.

### 4.2. OPI Mode

### Standard OPI

The GD25LX512ME supports Octal Peripheral Interface (OPI) operations only when the device is switched to OPI mode by setting byte<0> in Nonvolatile/Volatile Configuration Register. The OPI mode utilizes all 8 IO pins to input the command code. Input data is latched on the rising edge of SCLK and data shifts out on the falling edge of SCLK. Only one mode can be active at any given times. Upon power-up and after software reset using "Enable Reset (66H) and Reset (99H)" command, the state of the device is defined by the setting of byte<0> in Nonvolatile Configuration Register.

### **DTR OPI**

The GD25LX512ME supports DTR OPI operation when the device is switched to OPI mode by setting byte<0> in Nonvolatile/Volatile Configuration Register. The data input/output will be latched on both rising and falling edges of the serial clock. Only one mode can be active at any given times. Upon power-up and after software reset using "Enable Reset (66H) and Reset (99H)" command, the state of the device is defined by the setting of byte<0> in Nonvolatile Configuration Register.

#### 4.3. RESET Function

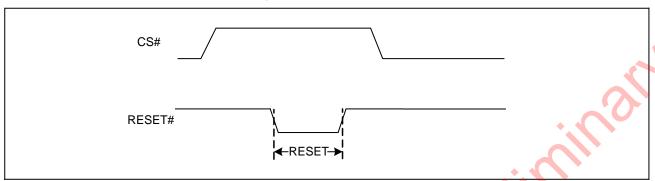
The RESET# pin allows the device to be reset by the control.

The RESET# pin goes low for a minimum period of tRLRH will reset the flash. After reset cycle, the flash is at the following states:

- -Standby mode
- -All the volatile bits will return to the default status as power on.



**Figure 1 RESET Condition** 



### 4.4. ECC Function

The ECC Correction Signal (ECS#) pin is provided to the system hardware designers to determine the ECC status during any Read operation. The ECS# pin will be pulled low during any 8-Byte Read data output period in which an ECC event has occurred. ECS# pin can be used to represent SEC (Single Error Correction). ECC Correction Signal Output pin is an Open-Drain connection.

### 4.5. Data Strobe Function

DQS signal indicates output data valid for DTR modes and is required to support high speed data output. DQS pin is used for READ but not for WRITE operations, which is configured by nonvolatile and volatile configuration register byte <0>. DQS pin is not required in extended-SPI protocol except to achieve high frequency for specific DTR commands. When data strobe function is enabled, DQS signal is driven to ground once CS# goes LOW till the device is driving output data, in which case DQS toggles to synchronize data output. When data strobe function is not enabled, DQS signal is not driven.



### 5. DATA PROTECTION

The GD25LX512ME provide the following data protection methods:

- ◆ Write Enable (WREN) command: The WREN command is set the Write Enable Latch bit (WEL). The WEL bit will return to reset by the following situation:
- -Power-Up/ Software reset (66H+99H)
- -Write Disable (WRDI)
- -Write Status Register (WRSR)
- -Write Extended Address Register (WEAR)
- -Write Nonvolatile Configuration Register (WNVCR)
- -Write Volatile Configuration Register (WVCR)
- -Page Program (PP)
- -Sector Erase (SE) / Block Erase (BE) / Chip Erase (CE)
- -Erase Security Registers / Program Security Registers
- Software Protection Mode:
- -The Block Protect (BP3, BP2, BP1, and BP0) bits and Top Bottom (TB) bit define the section of the memory array that can be read but cannot be changed.
- Individual Block Protection bit provides the protection selection of each individual block and sectors in the top and bottom block.
- ◆ Hardware Protection Mode: WP# goes low to protect the BP0~BP3 bits, TB bit and SRP0 bit.
- ◆ Deep Power-Down Mode: In Deep Power-Down Mode, all commands are ignored except the Release from Deep Power-Down Mode command and reset command (66H+99H).

Table 3. GD25LX512ME Protected area size

	Status Register Content			nt		Memory Content		
ТВ	BP3	BP2	BP1	BP0	Blocks	Addresses	Density	Portion
Х	0	0	0	0	NONE	NONE	NONE	NONE
0	0	0	0	1	1023	03FF0000h-03FFFFFh	64KB	Upper 1/1024
0	0	0	1	0	1022 to 1023	03FE0000h-03FFFFFh	128KB	Upper 1/512
0	0	0	1	5	1020 to 1023	03FC0000h-03FFFFFh	256KB	Upper 1/256
0	0	+	0	0	1016 to 1023	03F80000h-03FFFFFh	512KB	Upper 1/128
0	0	1	0	1	1008 to 1023	03F00000h-03FFFFFh	1MB	Upper 1/64
0	0	1	1	0	992 to 1023	03E00000h-03FFFFFh	2MB	Upper 1/32
0	0	1	1	1	960 to 1023	03C00000h-03FFFFFh	4MB	Upper 1/16
0	1	0	0	0	896 to 1023	03800000h-03FFFFFh	8MB	Upper 1/8
0	1	0	0	1	768 to 1023	03000000h-03FFFFFh	16MB	Upper 1/4
0	1	0	1	0	512 to 1023	02000000h-03FFFFFh	32MB	Upper 1/2
1	0	0	0	1	0	00000000h-0000FFFFh	64KB	Lower 1/1024
1	0	0	1	0	0 to 1	00000000h-0001FFFFh	128KB	Lower 1/512
1	0	0	1	1	0 to 3	00000000h-0003FFFFh	256KB	Lower 1/256
1	0	1	0	0	0 to 7	00000000h-0007FFFh	512KB	Lower 1/128
1	0	1	0	1	0 to 15	00000000h-000FFFFh	1MB	Lower 1/64

### GD25LX512ME

1	0	1	1	0	0 to 31	00000000h-001FFFFh	2MB	Lower 1/32
1	0	1	1	1	0 to 63	00000000h-003FFFFh	4MB	Lower 1/16
1	1	0	0	0	0 to 127	00000000h-007FFFFh	8MB	Lower 1/8
1	1	0	0	1	0 to 255	00000000h-00FFFFFh	16MB	Lower 1/4
1	1	0	1	0	0 to 511	00000000h-01FFFFFh	32MB	Lower 1/2
Х	1	1	Х	Х	ALL	00000000h-03FFFFFh	64MB	ALL
Х	1	0	1	1	ALL	00000000h-03FFFFFh	64MB	ALL

Table 4. GD25LX512ME Individual Block Protection (WPS=0)

Block	Sector	Addres	s range	Individual Block Lock Operation
	16383	03FF F000h	03FF FFFFh	1024 Blocks
1023				Block Lock: 36H+Address
	16368	03FF 0000h	03FF 0FFFh	Block Unlock: 39H+Address
1022		03FE 0000h	03FE FFFFh	Read Block Lock: 3DH+Address
				Global Block Lock: 7EH
				Global Block Unlock: 98H
1		0001 0000h	0001 FFFFh	
	15	0000 F000h	0000 FFFFh	<b>)</b>
0				
	0	0000 0000h	0000 0FFFh	

### Notes:

- 1. Protection configuration: This bit is used to select which Write Protect scheme should be used.
- 2. Volatile lock bits. Each volatile bit corresponds to and provides volatile protection for an individual memory sector, which is locked temporarily (protection is cleared when the device is reset or powered down).
- 3. The first and last sectors will have volatile protections at the 4KB sector level. Each 4KB sector in these sectors can be individually locked by volatile lock bits setting.



### 6. DATA INTEGRITY CHECK

The data storage and transmission errors will cause unexpected flash device variation that makes a harmful impact on overall system functions. To prevent these errors, GD25LX512ME product provides advanced Data Integrity Check function. For the data storage and data transmission in the flash device, Data Integrity Check can check errors and correct them, allowing self-checking and preventing errors in advance.

The Data Integrity Check function includes two methods:

- ECC (Error Checking and Correcting): to prevent the data storage errors
- Parity Check (Cyclic Redundancy Check): to prevent the data transmission errors

The register data and software signals can also be used to associate the Data Integrity Check function to fully record the results of checking, and can also immediately feedback.

### 6.1. ECC (Error Checking and Correcting)

Error Correction Codes (ECC) is a commonly used technique in non-volatile memory to reduce the device Bit Error Rate (BER) during the device operation life and improve device reliability. To achieve error detection and correction, redundancy data must be added to store the ECC calculation results for a given length of data. In GD25LX512ME, every aligned 8-Byte data (A[2:0] = 0, 0, 0) stored in the memory array will be checked by the internal ECC engine using SEC (Single Error Correction) Hsiao Codes algorithm. With 8-Byte ECC data granularity, ECC calculation latency time can be minimized and highest level of data integrity can be preserved.

The default value of all memory data is FFH (Erased) when the device is shipped from the factory. A "Page Program (02H/12H)" or an "Octal Page Program (82H/84H/8EH)" command can be used to program the user data into the memory array. When ECC is enabled (ECC=1 in Configuration Register), ECC calculation will be performed during the internal programming operation and the results are stored in the redundancy or spare area of the memory array. It is necessary to program every page in aligned 8-Byte granularity so that ECC engine can store the correct ECC information. It is also required that every aligned 8-Byte data granularity can only be programmed once to avoid additional ECC calculation in the same granularity resulting incorrect ECC results. A technique previously known as "Incremental Byte/Bit Programming to the same Byte location" cannot be used for GD25LX512ME when ECC is enabled.

During data read operations, the internal ECC engine will check the ECC results stored in the spare area and apply necessary error correction or error detection to the main array data being read out. It is necessary to check the ECC Status Bits (SEC) in the Status Register after every Read operation to see if the data read out contains one error or not. A Read operation can start from any Byte address and continue through the entire memory array, so it is not necessary to align the 8-Byte granularity boundary address to start a Read command.

Additional hardware monitoring of the ECC status can also be used to observe the ECC status in real time during any data output. When configured, the ECS# (ECC Correction Signal) pin will be pulled low during any aligned 8-Byte data output if it contains SEC event.

The ECC register bit can be reset through either of the following situations:

- Issuing Software Reset Command
- Hardware Reset
- Power-up cycle



### 6.2. ECS# (Error corrected Signal) Pin

The ECS# pin is a real time hardware signal to feedback the ECC correction status. The ECS# pin is designed as an open drain structure. In normal situation, the ECS# is kept on Hi-Z state. Once error correction begins, the ECS# pin will pull low during the whole ECC chunk unit after a duration of tECSV delay timing

The ECS# (ECC Correction Signal) pin will be pulled low during any aligned 8-Byte data output if it contains SEC (Single Error Correction) event.

SCLK

SCLK

IO[7:0]

Command & Address & Dummys

High-Z

High-Z

ECC chunk (8 Bytes)

ECC chunk (8 Bytes)

Figh-Z/

ECC chunk with
ECC chunk with
ECC chunk with
ECC chunk with

Figure 2. ECS# Timing

### 6.3. Parity Check (CRC)

The parity check function can only be operated at DTR OPI read, it does not support STR read. The bit7~6 in Byte<4> of the Configuration Register can set the parity check function.

For read operation after the Parity check function is enabled, the data CRC bit should be output by each CRC chunk unit. Otherwise, read CRC code might be error.

The CRC Chunk size can be configured as 16-Byte, 32-Byte, or 64-Byte by the Configuration Register setting. However, when the device enters the "Read with Wrap" mode, while the CRC function is also enabled, the CRC Chunk size will be set to be identical with the Wrap Length (16, 32 or 64 Byte) by internal circuitry. Only when the device is not in the "Read with Wrap" mode, the original CRC Chunk size setting will be restored.

The data CRC bytes are calculated by bitwise exclusive-OR of all the data bytes in the CRC chunk.

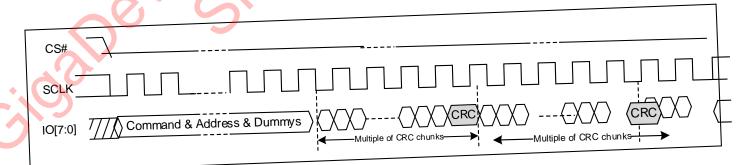


Figure 3. CRC Timing



### 7. STATUS AND EXTENDED ADDRESS REGISTERS

### 7.1. Status Register

No.	Bit Name	Description	Note
S0	WIP	Erase/Write In Progress	Volatile, read only
S1	WEL	Write Enable Latch	Volatile, read only
S2	BP0	Block Protect Bits	Non-volatile writable
S3	BP1	Block Protect Bits	Non-volatile writable
S4	BP2	Block Protect Bits	Non-volatile writable
S5	BP3	Block Protect Bits	Non-volatile writable
S6	ТВ	Top/Bottom Protect Bit	Non-volatile writable
S7	SRP0	Status Register Protection	Non-volatile writable

The status and control bits of the Status Register are as follows:

### **WIP** bit

The Write in Progress (WIP) bit indicates whether the memory is busy in program/erase/write status register or configuration register progress. When WIP bit sets to 1, means the device is busy in program/erase/write status register or configuration register progress, when WIP bit sets 0, means the device is not in program/erase/write status register or configuration register progress.

#### WEL bit

The Write Enable Latch (WEL) bit indicates the status of the internal Write Enable Latch. When set to 1 the internal Write Enable Latch is set, when set to 0 the internal Write Enable Latch is reset and no Write, Program or Erase command is accepted.

### TB bit

The Top Bottom (TB) bit is non-volatile. The Top/Bottom (TB) bit is used to configure the Block Protect area by BP bit (BP3, BP2, BP1, and BP0), starting from Top or Bottom of the memory array. The TB bit is defaulted as "0", which means Top area protect. When it is set to "1", the protect area will change to Bottom area of the memory device. This bit is written with the Write Status Register (WRSR) command.

### BP3, BP2, BP1, BP0 bits

The Block Protect (BP3, BP2, BP1, and BP0) bits are non-volatile. They define the size of the area to be software protected against Program and Erase commands. These bits are written with the Write Status Register (WRSR) command. When the Block Protect (BP3, BP2, BP1, and BP0) bits are set to 1, the relevant memory area becomes protected against Page Program (PP), Sector Erase (SE) and Block Erase (BE) commands. The Block Protect (BP3, BP2, BP1, and BP0) bits can be written provided that the Hardware Protected mode has not been set. The Chip Erase (CE) command is executed only if none sector or block is protected.

### SRP0 bit

The Status Register Protect SRP0 bit are non-volatile Read/Write bits in the status register. The SRP0 bit in conjunction



with SRP1 bit (Reference Configuration Register) control the method of write protection: software protection, hardware protection, power supply lock-down or one time programmable protection.

SRP1	SRP0	WP#	Status Register	Description
х	0	Х	Software Protected	The Status Register can be written to after a Write Enable command, WEL=1.(Default)
0	1	0	Hardware Protected	WP#=0, the Status Register locked and cannot be written to.
0	1	1	Hardware Unprotected	WP#=1, the Status Register is unlocked and can be written to after a Write Enable command, WEL=1.
1	1	Х	One Time Program <sup>(1)</sup>	Status Register is permanently protected and cannot be written to.

#### NOTE:

1. This feature is available on special order. Please contact GigaDevice for details.

### 7.2. Flag Status Register

No.	Bit Name	Description	Note
FS0	ADS	Current Address Mode	Volatile, read only
FS1	Protection	0:clear;1= failure or protection error	Volatile read only
FS2	SUS_P	Program Suspend	Volatile, read only
FS3	Reserved	Reserved	Reserved
FS4	PE	Program Error bit	Volatile, read only
FS5	EE	Erase Error bit	Volatile, read only
FS6	SUS_E	Erase Suspend	Volatile, read only
FS7	RY/BY#	Ready/Busy#	Volatile, read only

The status and control bits of the Flag Status Register are as follows:

#### ADS bit

The Address Status (ADS) bit is a read only bit that indicates the current address mode the device is operating in. The device is in 3-Byte address mode when ADS=0 (default), and in 4-Byte address mode when ADS=1.

### **Protection bit**

The Protection bit is a read only bit that indicates a program or erase failure. Indicates whether an ERASE or PROGRAM operation has attempted to modify the protected array sector, or whether a PROGRAM operation has attempted to access the locked OTP space.

Error bits can be reset by CLEAR FLAG STATUS REGISTER command (30H).

### SUS\_E, SUS\_P bits

The SUS\_E and SUS\_P bits are read only bits in the Flag Status Register (FS6 and FS2) that are set to 1 after executing an Erase/Program Suspend (75H) command (The Erase Suspend will set the SUS\_E to 1,and the Program Suspend will set the SUS\_P to 1). The SUS\_E and SUS\_P bit are cleared to 0 by Erase/Program Resume (7AH) command, software



reset (66H+99H) command as well as a power-down, power-up cycle.

#### PE bit

The Program Error (PE) bit is a read only bit that indicates a program failure. It will also be set when the user attempts to program a protected array sector or access the locked OTP space.

Error bits can be reset by CLEAR FLAG STATUS REGISTER command (30H).

#### **EE** bit

The Erase Error (EE) bit is a read only bit that indicates an erase failure. It will also be set when the user attempts to erase a protected array sector or access the locked OTP space.

Error bits can be reset by CLEAR FLAG STATUS REGISTER command (30H).

#### RY/BY# bit

The RY/BY# bit is a read only bit that indicates Program or Erase Status bit. Indicates whether one of the following command cycles is in progress: WRITE STATUS REGISTER, WRITE NONVOLATILE CONFIGURATION REGISTER, PROGRAM, or ERASE.

### 7.3. Extended Address Register

Note No. Name Description EA0 A24 Address bit Volatile writable EA1 Address bit A25 Volatile writable EA2 Reserved Reserved Reserved EA3 Reserved Reserved Reserved EA4 Reserved Reserved Reserved EA5 Reserved Reserved Reserved Reserved EA6 Reserved Reserved EA7 SEC **Error Correction bit** Volatile, read only

Table 5. Extended Address Register

The extended address register is only used when the address mode is 3-Byte mode, as to set the higher address. The default value of the bit in the extended address register is "0".

For the read operation, the whole array data can be continually read out with one command. Data output starts from the selected top or bottom 128Mb, and it can cross the boundary. When the last byte of the segment is reached, the next byte (in a continuous reading) is the first byte of the next segment. However, the EAR (Extended Address Register) value does not change. The random access reading can only be operated in the selected segment.

The Chip erase command will erase the whole chip and is not limited by EAR selected segment. However, the sector erase, block erase, program operation are limited in selected segment and will not cross the boundary.

### A25, A24 bits

The Extended Address Bits are used only when the device is operating in the 3-Byte Address Mode (ADS=0), which are volatile writable by C5H command.



A25, A24	Address	
00	0000 0000h-00FF FFFFh	
01	0100 0000h-01FF FFFFh	
10	0200 0000h-02FF FFFFh	
11	0300 0000h-03FF FFFFh	

If Configuration Register Byte <5> is set to FEH, or an "Enter 4-Byte Address Mode (B7H)" instruction is issued, the device will require 4-Byte address input for all address related instructions, and the Extended Address Bits will be ignored.

### **SEC** bits

SEC (Single Error Correction) Status Bit are used to show the ECC results for the last Read operation. SEC bit will be cleared to 0 once the device accepts a new Read command.

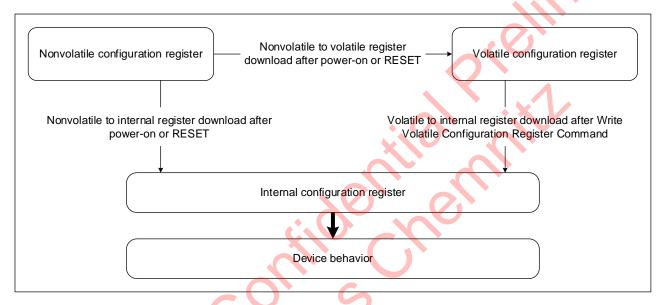
SEC	Definitions
0	No ECC events in all aligned 8-Byte granularities
1	SEC events in single or multiple 8-Byte granularities, and the data is OK to use. (Unless it contains more than one odd bit errors in 8-Byte granularity)



### 8. Internal Configuration Register

The memory configuration is set by an internal configuration register that is not directly accessible to users. The user can change the default configuration at power up by using the WRITE NONVOLATILE CONFIGURATION REGISTER. Information from the nonvolatile configuration register overwrites the internal configuration register during power on or after a reset.

The user can change the configuration during device operation using the WRITE VOLATILE CONFIGURATION REGISTER command. Information from the volatile configuration registers overwrite the internal configuration register immediately after the WRITE command completes.



### 8.1. Nonvolatile Configuration Register

Nonvolatile Configuration Register bits set the device configuration after power-up or reset. All bits are erased (FFh) unless stated otherwise. This register is read from and written to using the READ NONVOLATILE CONFIGURATION REGISTER and the WRITE NONVOLATILE CONFIGURATION REGISTER commands, respectively. The commands use the main array address scheme, but only the LSB is used to access different register settings, thereby providing up to 256 bytes of registers (See the table below for the details). A READ command from a reserved address returns FFh. A WRITE command to a reserved setting is ignored, flag status register bit 1 is set, and the write enable latch bit isn't cleared.

bit7 bit6 bit5 Addr Settings bit4 bit3 bit2 bit1 bit0 Description SPI with DQS (Default) SPI W/O DQS Octal DTR with DQS Octal DTR W/O DQS <0> I/O mode Octal with DQS Octal W/O DQS The Same as Default Value (SPI Others with DQS)

Table 6. Nonvolatile Configuration Register





		0	0	0	0	0	0	0	0	default	
		0	0	0	0	0	0	1	1	3 Dummy	
		0	0	0	0	0	1	0	0	4 Dummy	
<1>	Dummy cycle									05~1D: 5~29 Dummy	
	configuration(1-7)	0	0	0	1	1	1	1	0	30 Dummy	
		0.11			I.	Initiation Dummy According to					
		Othe	rs				Specific Command				
									_	Security Registers Unlocked	
	<2> OTP configuration	Х	Х	Х	Х	Х	Х	Х	0	(Default)	
<2>		Х	х	Х	х	х	х	х	1	Security Registers Locked	
		Х	х	Х	0	х	х	х	х	SRP1 Unlocked (Default)	
		Х	х	х	1	х	х	х	х	SRP1 Locked	
		1	1	1	1	1	1	1	1	50 Ohm (Default)	
		1	1	1	1	1	1	1	0	35 Ohm	
.0.	Driver Strength	1	1	1	1	1	1	0	1	25 Ohm	
<3>	configuration	1	1	1	1	1	1	0	0	18 Ohm	
		Other			I.					The Same as Default Value (50	
		Othe	rs				( )			Ohm)	
	222	1	1	х	х	x	х	х	x	CRC Disabled (Default)	
		1	0	х	x	x	х	X	х	16-Byte CRC	
	CRC configuration	0	1	х	Х	Х	X	х	х	32-Byte CRC	
		0	0	х	Х	х	х	х	х	64-Byte CRC	
		Х	х	1	1	x	х	х	х	ODT Disabled (Default)	
		х	х	1	0	Х	х	х	х	150-Ohm ODT	
<4>	On die termination	Х	х	0	1	х	х	х	х	100-Ohm ODT	
<4>		x	х	0	1	х	х	х	х	50-Ohm ODT	
	DI D configuration	х	х	Х	X	1	х	х	х	DLP Disabled (Default)	
	DLP configuration	х	х	Х	х	0	х	х	х	DLP Enabled	
	Protection	Х	x	х	х	х	1	х	х	BP Protection (Default)	
	configuration	X	х	Х	х	х	0	х	х	WPS Protection <sup>(8)</sup>	
•	ECC configuration	х	х	Х	х	х	х	х	1	ECC Enabled	
	ECC configuration	Х	х	х	х	х	х	х	0	ECC Disabled (Default)	
4	<b>7</b>	1	1	1	1	1	1	1	1	3-Byte Address (Default)	
	Beyond 128Mb	1	1	1	1	1	1	1	0	4-Byte Address	
<5>	addr configuration	٠٠٠ -								The Same as Default Value (3-	
		Other	S							Byte Address)	
		1	1	1	1	1	1	1	1	XIP Disabled (Default)	
40.	Continuous Read	1	1	1	1	1	1	1	0	XIP Enabled	
<6>	configuration(9)	Othe								The Same as Default Value (XIP	
		Othe	S							Disabled)	
<b>بر</b>	Wrap	1	1	1	1	1	1	1	1	Wrap Disabled (Default)	
<7>	configuration <sup>(10)</sup>	1	1	1	1	1	1	1	0	64-Byte Wrap	
	•	•					•				



	1	1	1	1	1	1	0	1	32-Byte Wrap	
	1	1	1	1	1	1	0	0	16-Byte Wrap	
	Others								The Same as Default Value (Wrap	
	Other	S							Disabled)	

#### Notes:

- 1. The number of cycles must be set to accord with the clock frequency, which varies by the type of FAST READ command (See Supported Clock Frequencies table). Insufficient dummy clock cycles for the operating frequency causes the memory to read incorrect data.
- 2. 03H/13H: SPI 0 dummy; OPI&DTR N/A
- 3. 05H/70H/9EH/9FH: SPI 0dummy; OPI&DTR 8 dummy.
- 4. 3DH: SPI 0dummy; OPI&DTR 8 dummy.
- 5. 4BH/5AH/B5H/85H: SPI&OPI&DTR 8 dummy.
- 6. 0BH/0CH/8BH/7CH/48H: SPI 8 dummy; OPI&DTR dummy follow CONFIGURATION REGISTER<2> (initiation = 16 dummy)
- 7. CBH/CCH/FDH: SPI&OPI&DTR dummy follow CONFIGURATION REGISTER<2> (initiation = 16 dummy)
- 8. When WPS protection is enabled, the entire memory array is being protected after Power-up or Reset.
- 9. Only Octal I/O Fast Read (CBH/CCH) and DTR Octal I/O Fast Read (FDH) support Continuous Read.
- 10. Only Octal I/O Fast Read (CBH/CCH) and DTR Octal I/O Fast Read (FDH) support Wrap read.

### 8.2. Volatile Configuration Register

Volatile Configuration Register bits temporarily set the device configuration after power-up or reset. All bits are erased (FFh) unless stated otherwise. This register is read from and written to using the READ NONVOLATILE CONFIGURATION REGISTER commands, respectively. The commands use the main array address scheme; however, only the LSB is used to access different register settings to provide up to 256 bytes of registers (See the table below for the details). A READ command from a reserved address returns FFh. A WRITE command to a reserved setting is ignored, flag status register bit 1 is set, and the write enable latch bit isn't cleared.

Table 7. Volatile Configuration Register

Addr	Settings	bit7	bit6	bit5	bit4	bit3	bit2	bit1	bit0	Description
		1	1	1	1	1	1	1	1	SPI with DQS (Default)
		1	1	0	1	1	1	1	1	SPI W/O DQS
. 6		1	1	1	0	0	1	1	1	Octal DTR with DQS
<0>	I/O mode	1	1	0	0	0	1	1	1	Octal DTR W/O DQS
203	I/O mode	1	0	1	1	0	1	1	1	Octal with DQS
		1	0	0	1	0	1	1	1	Octal W/O DQS
		Othe	70					The Same as Default Value (SPI		
		Other	5							with DQS)
		0	0	0	0	0	0	0	0	default
	Dummy avala	0	0	0	0	0	0	1	1	3 Dummy
<1>	<1> Dummy cycle configuration <sup>(1-7)</sup>	0	0	0	0	0	1	0	0	4 Dummy
Configurati	Configuration									05~1D: 5~29 Dummy
		0	0	0	1	1	1	1	0	30 Dummy



		Othe	rs					Initiation Dummy According to Specific Command		
<2>	Reserved	х	х	х	х	х	х	х	0	Reserved
		1	1	1	1	1	1	1	1	50 Ohm (Default)
		1	1	1	1	1	1	1	0	35 Ohm
۰۵.	<3> Driver Strength configuration	1	1	1	1	1	1	0	1	25 Ohm
<3>		1	1	1	1	1	1	0	0	18 Ohm
		Othe	rs							The Same as Default Value (50 Ohm)
		1	1	х	х	х	х	х	х	CRC Disabled (Default)
	CBC configuration	1	0	х	х	х	х	х	х	16-Byte CRC
	CRC configuration	0	1	х	х	х	х	х	х	32-Byte CRC
		0	0	х	х	х	х	х	x	64-Byte CRC
		х	х	1	1	х	х	х	х	ODT Disabled (Default)
	On die termination	Х	х	1	0	х	Х	x	Х	150-Ohm ODT
-15	<4>	Х	х	0	1	х	х	х	х	100-Ohm ODT
< <del>4</del> >		Х	х	0	1	х	Х	X	х	50-Ohm ODT
		х	х	х	х	1	Х	х	x	DLP Disabled (Default)
	DLP configuration	Х	х	х	х	0	х	х	x	DLP Enabled
	Protection	Х	х	х	x	x	1	x	х	BP Protection (Default)
	configuration	Х	х	х	X	Х	0	x	х	WPS Protection <sup>(8)</sup>
	ECC configuration	Х	х	x	X	х	х	х	1	ECC Enabled
	ECC configuration	х	X	х	х	x	х	х	0	ECC Disabled (Default)
		1	1	1	1	1 -	1	1	1	3-Byte Address (Default)
<5>	Beyond 128Mb	1	1	1	1	1	1	1	0	4-Byte Address
)	addr configuration	Othe	rs	2	0					The Same as Default Value (3-Byte Address)
		1	1	1	1	1	1	1	1	XIP Disabled (Default)
<6>	Continuous Read	1	1	1	1	1	1	1	0	XIP Enabled
<b>10</b> 2	configuration <sup>(9)</sup>	Othe	70							The Same as Default Value (XIP
•		Other								Disabled)
		1	1	1	1	1	1	1	1	Wrap Disabled (Default)
A'		1	1	1	1	1	1	1	0	64-Byte Wrap
<7>	Wrap	1	1	1	1	1	1	0	1	32-Byte Wrap
7,70	configuration(10)	1	1	1	1	1	1	0	0	16-Byte Wrap
,		Othe	rs			The Same as Default Value (Wrap Disabled)				

### Notes:

- 1. The number of cycles must be set to accord with the clock frequency, which varies by the type of FAST READ command (See Supported Clock Frequencies table). Insufficient dummy clock cycles for the operating frequency causes the memory to read incorrect data.
- 2. 03H/13H: SPI 0 dummy; OPI&DTR N/A
- 3. 05H/70H/9EH/9FH: SPI 0dummy; OPI&DTR 8 dummy.



- 4. 3DH: SPI 0dummy; OPI&DTR 8 dummy.
- 5. 4BH/5AH/B5H/85H: SPI&OPI&DTR 8 dummy.
- 6. 0BH/0CH/8BH/7CH/48H: SPI 8 dummy; OPI&DTR dummy follow CONFIGURATION REGISTER<2> (initiation = 16 dummy)
- 7. CBH/CCH/FDH: SPI&OPI&DTR dummy follow CONFIGURATION REGISTER<2> (initiation = 16 dummy)
- 8. When WPS protection is enabled, the entire memory array is being protected after Power-up or Reset.
- 9. Only Octal I/O Fast Read (CBH/CCH) and DTR Octal I/O Fast Read (FDH) support Continuous Read.
- 10. Only Octal I/O Fast Read (CBH/CCH) and DTR Octal I/O Fast Read (FDH) support Wrap read.

#### **DLP** bit

The DLP bit is Data Learning Pattern Enable bit, which is writable by B1/81H command. For Octal output, Octal I/O and Octal I/O DTR Fast Read commands, a pre-defined "Data Learning Pattern" can be used by the flash memory controller to determine the flash data output timing on 8 I/O pins. When DLP=1, from the failing edge of the fourth dummy clock, the flash will output "00110100" Data Learning Pattern sequence on each of the I/O or 8 I/O pins until data output. If the dummy clock is not enough for the output of the whole Data Learning Pattern, the last several bit of the Data Learning Pattern would be cut-off. During this period, controller can fine tune the data latching timing for each I/O pins to achieve optimum system performance. DLP=0 will disable the Data Learning Pattern output.

Figure 4. Data Learning Pattern Sequence Diagram (STR, Dummy Clock ≥ 12)

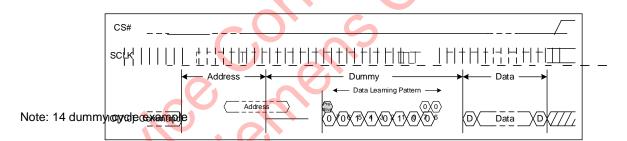
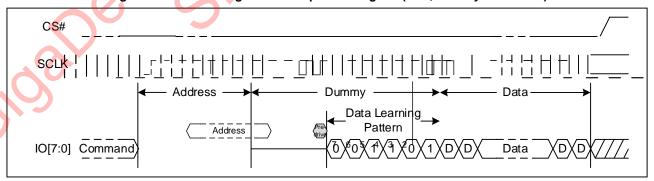
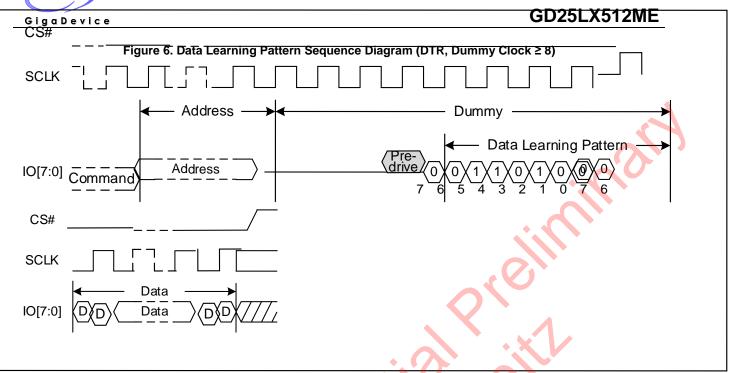


Figure 5. Data Learning Pattern Sequence Diagram (STR, Dummy Clock < 12)

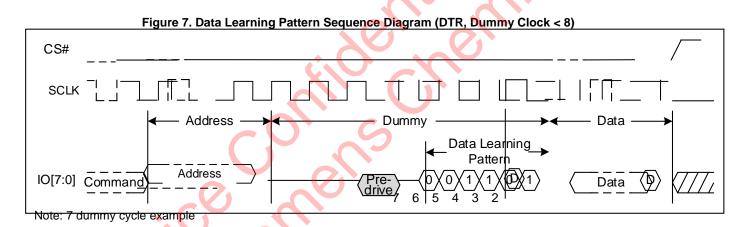


Note: 10 dummy cycle example





Note: 9 dummy cycle example





### 8.3. Supported Clock Frequencies

Table 2. Clock Frequencies of TFBGA-24 (5x5 Ball Array)

	<u> </u>		<b>77</b>		
Number of Dummy Clock	Octal I/C	FAST READ	OPI DTR		
Cycle	SDR	DTR	OFIDIR		
3	20	20	20		
4	40	40	40		
5	60	60	60		
6	84	84	84		
7	84	84	84		
8	104	104	104		
9	104	104	104		
10	133	133	133		
11	133	133	133		
12	152	152	152		
13	152	152	152		
14	166	166	166		
15	166	166	166		
16 and above	166	200	200		

Note:

Table 3. Clock Frequencies of SOP16 (300mil)

Number of Dummy Clock	Octal I/O F	AST READ	OPI DTR
Cycle	SDR	DTR	OPIDIK
3	20	20	20
4	40	40	40
5	60	60	60
6	84	84	84
7	84	84	84
8	104	104	104
9	104	104	104
10	133	133	133
11	133	133	133
12	152	152	152
13	152	152	152
14 and above	166	166	166

Note:

<sup>1.</sup> Values are guaranteed by characterization and not 100% tested in production

<sup>1.</sup> Values are guaranteed by characterization and not 100% tested in production



### 8.4. Data Sequence Wraps by Density

**Table 4 Sequence of Bytes during Wrap** 

Starting Address	16-Byte Wrap	32-Byte Wrap	64-Byte Wrap
0	0-1-215-0-1	0-1-231-0-1	0-1-263-0-1
1	1-215-0-1-2	1-231-0-1-2	1-263-0-1-2
15	15-0-1-2-315-0-1	15-16-1731-0-1	15-16-1763-0-1
31	-	31-0-1-2-331-0-1	31-32-3363-0-1
63	-	-	63-0-163-0-1



### 9. COMMANDS DESCRIPTION

All commands, addresses and data are shifted in and out of the device, beginning with the most significant bit on the first rising edge of SCLK after CS# is driven low. Then, the one-byte command code must be shifted in to the device, with most significant bit first on SI, and each bit is latched on the rising edges of SCLK.

Every command sequence starts with a one-byte command code. Depending on the command, this might be followed by address bytes, or by data bytes, or by both or none. CS# must be driven high after the last bit of the command sequence has been completed. For the command of Read, Fast Read, Read Status Register or Release from Deep Power-Down, and Read Device ID, the shifted-in command sequence is followed by a data-out sequence. All read instruction can be completed after any bit of the data-out sequence is being shifted out, and then CS# must be driven high to return to deselected status.

For the command of Page Program, Sector Erase, Block Erase, Chip Erase, Write Status Register, Write Enable, Write Disable or Deep Power-Down command, CS# must be driven high exactly at a byte boundary, otherwise the command is rejected, and is not executed. That is CS# must be driven high when the number of clock pulses after CS# being driven low is an exact multiple of eight. For Page Program, if at any time the input byte is not a full byte, nothing will happen and WEL will not be reset.

Table 10 Commands (Extended/Octal SPI)

		Extend	led SPI		Octal SPI			
Command name	Code	CMD-Addr- Data	Dummy Clock Cycles	CMD- Addr- Data (S-D-D)	CMD- Addr- Data (S-S-S)	Dummy Clock Cycles	Addr. Bytes	Data Bytes
Software Reset Op	erations							
Reset Enable	66h	1-0-0	0	8-0-0	8-0-0	0	0	0
Reset Memory	99h	1-0-0	0	8-0-0	8-0-0	0	0	0
Read ID Operations	S							
Read ID	9E/9Fh	1-0-(1)	0	8-0-(8)	8-0-(8)	8	0	1 to 4
Read Serial Flash Discovery Parameter	5Ah	1-1-(1)	8	8-8-(8)	8-8-(8)	8	3 (STR) 4 (DTR)	1 to ∞
Read Unique ID	4Bh	1-1-(1)	8	8-8-(8)	8-8-(8)	8	3(4)	1 to ∞
Read Memory Ope	rations							
Read	03h	1-1-(1)	0	_	_		3(4)	1 to ∞
Fast Read	0Bh	1-1-(1)	8	8-8-(8)	8-8-(8)	16	3(4)	1 to ∞
Octal Output Fast Read	8Bh	1-1-(8)	8	8-8-(8)	8-8-(8)	16	3(4)	1 to ∞
Octal I/O Fast Read	CBh	1-8-(8)	16	8-8-(8)	8-8-(8)	16	3(4)	1 to ∞
Read Memory Ope	rations wi	th 4-Byte Add	ress					
4-Byte Read	13h	1-1-(1)	0	_	_		4	1 to ∞
4-Byte Fast Read	0Ch	1-1-(1)	8	8-8-(8)	8-8-(8)	16	4	1 to ∞
4-Byte Octal Output Fast Read	7Ch	1-1-(8)	8	8-8-(8)	8-8-(8)	16	4	1 to ∞





4-Byte Octal I/O	CCh	1-8-(8)	16	8-8-(8)	8-8-(8)	16	4	1 to ∞
Fast Read	COII	1-0-(0)	10	0-0-(0)	0-0-(0)	10		1 10 33
4-Byte DTR Octal	FDh	1-8-(8)	16	8-8-(8)	8-8-(8)	16	4	1 to ∞
I/O Fast Read	1 511	1 0 (0)	10	0 0 (0)	0 0 (0)	10		1 10
Write Operations								
Write Enable	06h	1-0-0	0	8-0-0	8-0-0	0	0	0
Write Disable	04h	1-0-0	0	8-0-0	8-0-0	0	0	0
Read Register Ope	erations							
Read Status	054	4.0 (4)	0	0.0.(0)	0.0 (0)	8		4.6
Register	05h	1-0-(1)	0	8-0-(8)	8-0-(8)	8	0	1 to ∞
Read Flag Status	706	4.0 (4)	0	0.0.(0)	0.0 (0)		0	1 45
Register	70h	1-0-(1)	0	8-0-(8)	8-0-(8)	8	0	1 to ∞
Read Extended	001	4.0 (4)		0.0 (0)	0.0 (0)			4
Addr. Register	C8h	1-0-(1)	0	8-0-(8)	8-0-(8)	8	0	1
Read Nonvolatile						* *		
Configuration	B5h	1-1-(1)	8	8-8-(8)	8-8-(8)	8	3(4)	1
Register				X				
Read Volatile								
Configuration	85h	1-1-(1)	8	8-8-(8)	8-8-(8)	8	3(4)	1
Register								
Write Register Ope	erations		11					
Write Status	041	4.0.4		0.00	0.00	0		_
Register	01h	1-0-1	0	8-0-8	8-0-8	0	0	1
Write Extended	051				0.00	•		4
Addr. Register	C5h	1-0-1	0	8-0-8	8-0-8	0	0	1
Volatile SR	501			0.00				
Write Enable	50h	1-0-0	0	8-0-0	8-0-0	0	0	0
Write Nonvolatile								
Configuration	B1h	1-1-1	0	8-8-8	8-8-8	0	3(4)	1
Register		Call						
Write Volatile								
Configuration	81h	1-1-1	0	8-8-8	8-8-8	0	3(4)	1
Register								
Clear Flag Status F	Register O	peration						
Clear Flag Status				_				
Register	30h	1-0-0	0	8-0-0	8-0-0	0	0	0
Program Operation	าร							
								1 to
Page Program	02h	1-1-1	0	8-8-8	8-8-8	0	3(4)	256
Octal Input Fast								1 to
Program	82h	1-1-8	0	8-8-8	8-8-8	0	3(4)	256
- 9								





	1	Г	Г	Г					
Extended Octal								1 to	
Input Fast	C2h	1-8-8	0	8-8-8	8-8-8	0	3(4)	256	
Program									
Program Operation	Program Operations with 4-Byte Address								
4-Byte Page	12h	1-1-1	0	8-8-8	8-8-8	0	4	1 to	
Program	1211		Ů	000	000		·	256	
4-Byte Octal Input	84h	1-1-8	0	8-8-8	8-8-8	0	4	1 to	
Fast Program	0411	1-1-0	Ů			Ů		256	
4-Byte Octal Input						+ 4		1 to	
Extended Fast	8Eh	1-8-8	0	8-8-8	8-8-8	0	4	256	
Program								200	
Erase Operations									
4KB Sector Erase	20h	1-1-0	0	8-8-0	8-8-0	0	3(4)	0	
32KB Block Erase	52h	1-1-0	0	8-8-0	8-8-0	0	3(4)	0	
64KB Block Erase	D8h	1-1-0	0	8-8-0	8-8-0	0	3(4)	0	
Chip Erase	C7h/60	1-0-0	0	8-0-0	8-0-0	0	0	0	
Chip Erase	h	1-0-0	U	8-0-0	8-0-0		O	U	
Erase Operations with 4-Byte Address									
4-Byte 4KB Sector	245	4.4.0	0	8-8-8	0.00	0	4	0	
Erase	21h	1-1-0	0	8-8-8	8-8-0	0	4	0	
4-Byte 32KB	5Ch	1-1-0	0	8-8-8	0.00	0	4	0	
Block Erase	5Cn	1-1-0	0	0-0-0	8-8-0	0	4	U	
4-Byte 64KB	DCh	1.1.0-	0	8-8-0	0.0.0	0	4	0	
Block Erase	DCn	1-1-0		0-0-0	8-8-0	0	4	U	
Suspend/Resume	Operations	s							
Program/Erase	75h	1-0-0		8-0-0	8-0-0	0	0	0	
Suspend	7311	1-0-0		6-0-0	6-0-0	U	U	U	
Program/Erase	7Ah	1-0-0	0	8-0-0	8-0-0	0	0	0	
Resume	/All	1-0-0		8-0-0	8-0-0	O	O	U	
One-Time Program	mable(OT	P) Operations	5						
Read OTP Array	48h	1-1-(1)	8	8-8-(8)	8-8-(8)	16	3(4)	1 to ∞	
Program OTP	42h	1-1-1	0	8-8-8	8-8-8	0	3(4)	1 to	
Array	4211	1-1-1	O	0-0-0	0-0-0	O	3(4)	256	
Erase OTP Array	44h	1-1-0	0	8-8-0	8-8-0	0	3(4)	0	
4-ByteAddress Mode Operations									
Enter 4-Byte	B7h	1-0-0	0	8-0-0	8-0-0	0	0	0	
Address Mode	0/11	1-0-0	U	0-0-0	0-0-0	U		U U	
Exit 4-Byte	E9h	1-0-0	0	8-0-0	8-0-0	0	0	0	
Address Mode	Lan	1-0-0	<u> </u>	0-0-0	0-0-0	<u> </u>		0	
Deep Power-Down Operations									
Enter Deep Power	B9h	1-0-0	0	8-0-0	8-0-0	0	0	0	
Down	וופט	1-0-0	<u> </u>	0-0-0	0-0-0	<u> </u>		<u> </u>	



### GD25LX512ME

Release From Deep Power Down	ABh	1-0-0	0	8-0-0	8-0-0	0	0	0
Advanced Sector Protection Operations								
Individual sector lock	36h	1-1-0	0	8-8-0	8-8-0	0	3(4)	0
Individual sector unlock	39h	1-1-0	0	8-8-0	8-8-0	0	3(4)	0
Read sector lock	3Dh	1-1-(1)	0	8-8-(8)	8-8-(8)	8	3(4)	1
Global sector lock	7Eh	1-0-0	0	8-0-0	8-0-0	0	0	0
Global sector unlock	98h	1-0-0	0	8-0-0	8-0-0	0	0	0

# Table of ID Definitions GD25LX512ME

Operation Code	M7-M0	ID23-ID16	ID15-ID8	ID7-ID0
9E/9FH	C8	68	1A	FF



### 9.1. Enable 4-byte Mode (B7H)

The Enable 4-byte Mode command enables accessing the address length of 32-bit for the memory area of the higher density (larger than 128Mb). The GD25LX512ME default is in 24-bit address mode. After sending the Enable 4-byte Mode command, the ADS bit (FS0) will be set to 1 to indicate the 4-byte address mode has been enabled. Once the 4-byte address mode is enabled, the address length becomes 32-bit instead of the default 24 bit. The Disable 4-byte mode or Reset or Power-off will disable 4-byte mode.

Figure 8. Enable 4-byte Mode Sequence Diagram (SPI)

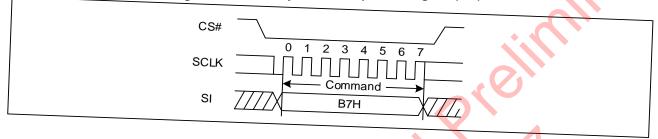
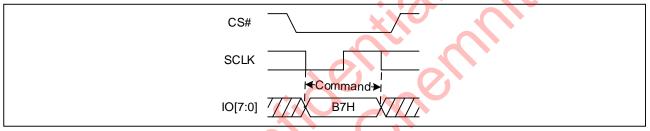


Figure 9. Enable 4-byte Mode Sequence Diagram (OPI)



### 9.2. Disable 4-byte Mode (E9H)

The Disable 4-byte Mode command is executed to exit the 4-byte address mode and return to the default 3-byte address mode. After sending the Disable 4-byte Mode command, the ADS bit (FS0) will be clear to be 0 to indicate the 4-byte address mode has been disabled, and then the address length will return to 24-bit.

Figure 10. Disable 4-byte Mode Sequence Diagram (SPI)

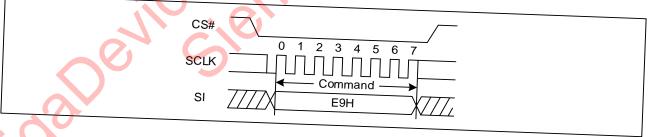
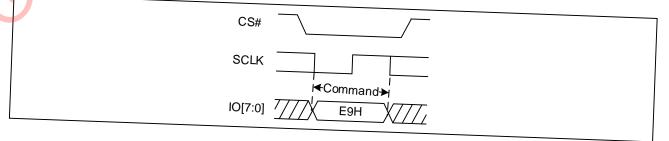


Figure 11. Disable 4-byte Mode Sequence Diagram (OPI)





### 9.3. Write Enable (WREN) (06H)

The Write Enable (WREN) command is for setting the Write Enable Latch (WEL) bit. The Write Enable Latch (WEL) bit must be set prior to every Page Program (PP), Sector Erase (SE), Block Erase (BE), Chip Erase (CE), Write Status Register (WRSR), Write Extended Address Register (WEAR), Write Nonvolatile/Volatile configure register and Erase/Program Security Registers command. The Write Enable (WREN) command sequence: CS# goes low → sending the Write Enable command → CS# goes high.

Figure 12. Write Enable Sequence Diagram (SPI)

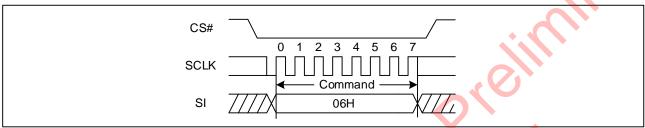
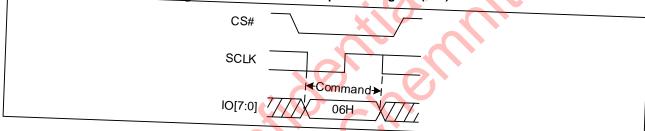


Figure 13. Write Enable Sequence Diagram (OPI)



### 9.4. Write Disable (WRDI) (04H)

The Write Disable command is for resetting the Write Enable Latch (WEL) bit. The Write Disable command sequence: CS# goes low →Sending the Write Disable command →CS# goes high. The WEL bit is reset by following condition: Power-up and upon completion of the Write Status Register, Write Extended Address Register (WEAR), Write Nonvolatile/Volatile configure register, Page Program, Sector Erase, Block Erase, Chip Erase, Erase/Program Security Registers and Reset commands.

Figure 14. Write Disable Sequence Diagram (SPI)

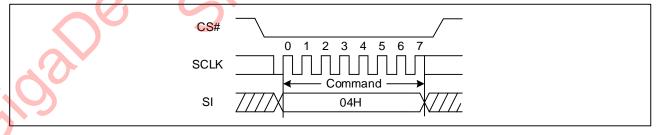
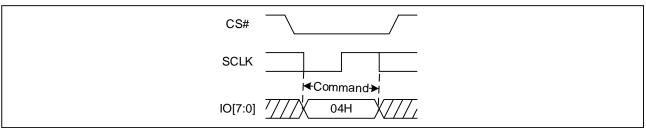


Figure 15. Write Disable Sequence Diagram (OPI)





### 9.5. Write Enable for Volatile Status Register (50H)

The non-volatile Status Register bits can also be written to as volatile bits. This gives more flexibility to change the system configuration and memory protection schemes quickly without waiting for the typical non-volatile bit write cycles or affecting the endurance of the Status Register non-volatile bits. The Write Enable for Volatile Status Register command must be issued prior to a Write Status Register command, and any other commands cannot be inserted between them. Otherwise, Write Enable for Volatile Status Register will be cleared. The Write Enable for Volatile Status Register command will not set the Write Enable Latch bit, it is only valid for the Write Status Register command to change the volatile Status Register bit values.

Figure 16. Write Enable for Volatile Status Register Sequence Diagram (SPI)

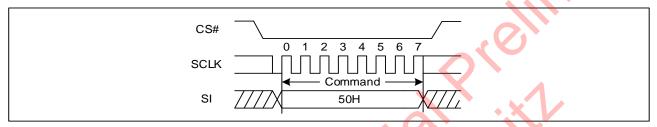
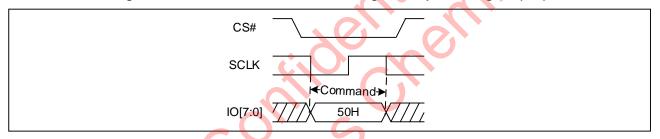


Figure 17. Write Enable for Volatile Status Register Sequence Diagram (OPI)



### 9.6. Write Status Register (WRSR) (01H)

The Write Status Register (WRSR) command allows new values to be written to the Status Register. Before it can be accepted, a Write Enable (WREN) command must previously have been executed. After the Write Enable (WREN) command has been decoded and executed, the device sets the Write Enable Latch (WEL).

The Write Status Register (WRSR) command has no effect on Byte2 of the Status Register. CS# must be driven high after the eighth of the data Byte has been latched in. If not, the Write Status Register (WRSR) command is not executed. As soon as CS# is driven high, the self-timed Write Status Register cycle (whose duration is tW) is initiated. While the Write Status Register cycle is in progress, the Status Register may still be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Write Status Register cycle, and is 0 when it is completed. When the cycle is completed, the Write Enable Latch (WEL) is reset.

The Write Status Register (WRSR) command allows the user to change the values of the Block Protect (TB, BP3, BP2, BP1, and BP0) bits, to define the size of the area that is to be treated as read-only. The Write Status Register (WRSR) command also allows the user to set or reset the Status Register Protect (SRP0) bit in accordance with the Write Protect (WP#) signal. The Status Register Protect (SRP1 and SRP0) bits and Write Protect (WP#) signal allow the device to be put in the Hardware Protected Mode. The Write Status Register (WRSR) command is not executed once the Hardware Protected Mode is entered.



Figure 18. Write Status Register Sequence Diagram (SPI)

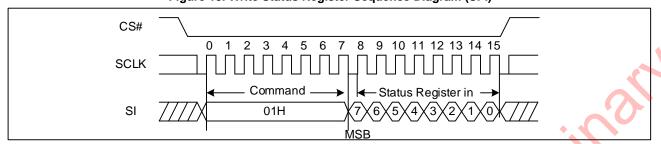
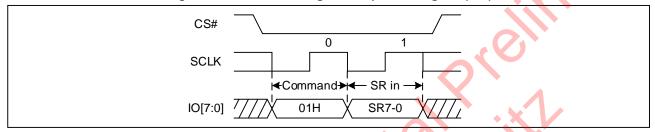


Figure 19. Write Status Register Sequence Diagram (OPI)



### 9.7. Write Extended Address Register (C5H)

The Extended Address Register is a volatile register that stores the 4th byte address (A31-A24) when the device is operating in the 3-Byte Address Mode (ADS=0). To write the Extended Address Register bits, a Write Enable (06H) instruction must previously have been executed for the device to accept the Write Extended Address Register instruction (Status Register bit WEL must equal 1). Once write enabled, the instruction is entered by driving /CS low, sending the instruction code "C5H", and then writing the Extended Address Register data byte.

Upon power up or the execution of a Software/Hardware Reset, the Extended Address Register bit values will be cleared to 0.

The Extended Address Register is only effective when the device is in the 3-Byte Address Mode. When the device operates in the 4-Byte Address Mode (ADS=1), any command with address input of A31-A24 will replace the Extended Address Register values. It is recommended to check and update the Extended Address Register if necessary when the device is switched from 4-Byte to 3-Byte Address Mode.

Figure 20. Write Extended Address Register Sequence Diagram (SPI)

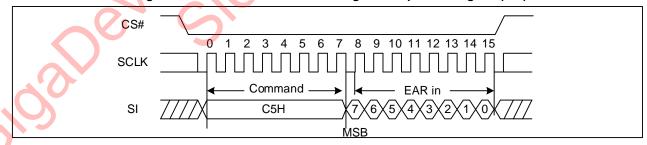
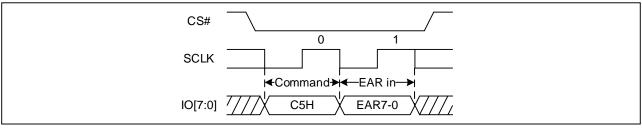


Figure 21. Write Extended Address Register Sequence Diagram (OPI)





### 9.8. Write Nonvolatile/Volatile Configuration Register (WRCR) (B1H/81H)

The Write Nonvolatile/Volatile Configuration Register (WRCR) command allows new values to be written to the Nonvolatile/Volatile Configuration Register. Before it can be accepted, a Write Enable (WREN) command must previously have been executed. After the Write Enable (WREN) command has been decoded and executed, the device sets the Write Enable Latch (WEL).

CS# must be driven high after the data Byte has been latched in. If not, the Write Configuration Register (WRCR) command is not executed. As soon as CS# is driven high, the self-timed Write Configuration Register cycle is initiated. While the Write Configuration Register cycle is in progress, the Configuration Register may still be read to check the value of the Write In Progress (WIP) bit. The Write In Progress (WIP) bit is 1 during the self-timed Write Configuration Register cycle, and is 0 when it is completed. When the cycle is completed, the Write Enable Latch (WEL) is reset.

CS#

0 1 2 3 4 5 6 7 8 9 28 29 30 31 32 33 34 35 36 37 38 39

SCLK

Command

Command

24-bit address

Configuration register in

B1H/81H

23/22/21

MSB

MSB

Figure 22. Write Nonvolatile/Volatile Configuration Register Sequence Diagram (SPI)

Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

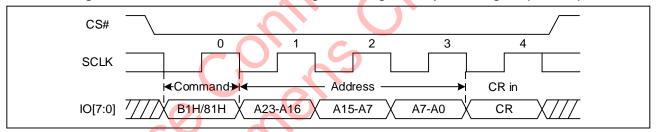


Figure 23. Write Nonvolatile/Volatile Configuration Register Sequence Diagram (STR OPI)

Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

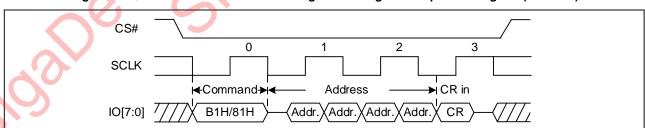


Figure 24. Write Nonvolatile/Volatile Configuration Register Sequence Diagram (DTR OPI)

### 9.9. Read Status Register (RDSR) (05H)

The Read Status Register (RDSR) command is for reading the Status Register. The Status Register may be read at any time, even while a Program, Erase or Write Status Register cycle is in progress. When one of these cycles is in progress, it is recommended to check the Write in Progress (WIP) bit before sending a new command to the device. It is also possible to read the Status Register continuously. The SO will output Status Register bits S7~SO.



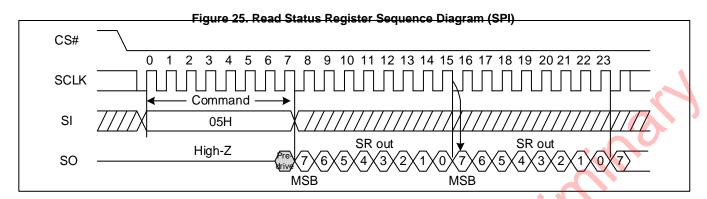


Figure 26. Read Status Register (RDSR) Sequence (STR OPI)

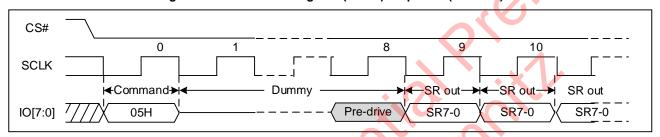
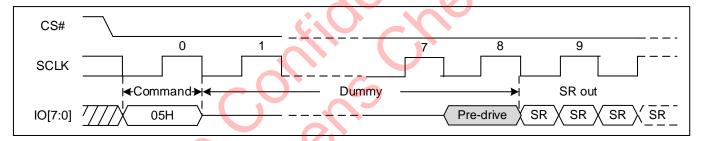


Figure 27. Read Status Register (RDSR) Sequence (DTR OPI)



### 9.10. Read Flag Status Register (RDSR) (70H)

The Read Flag Status Register command is for reading the Flag Status Register. The Flag Status Register may be read at any time, even while a Program, Erase or Write Status Register cycle is in progress. When one of these cycles is in progress, it is recommended to check the Write in Progress (WIP) bit before sending a new command to the device. It is also possible to read the Flag Status Register continuously. The SO will output Status Register bits FS7~FSO.

Figure 28. Read Status Register Sequence Diagram (SPI)

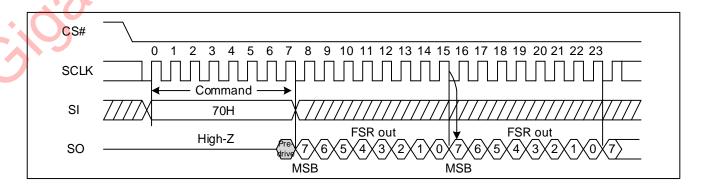




Figure 29. Read Status Register (RDSR) Sequence (STR OPI)

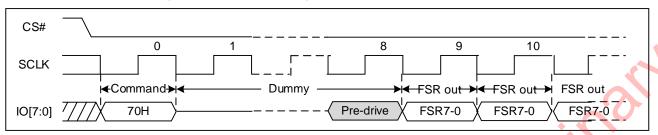
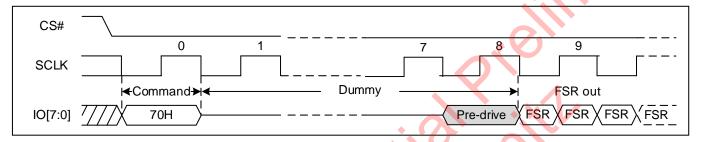


Figure 30. Read Status Register (RDSR) Sequence (DTR OPI)



# 9.11. Read Nonvolatile/Volatile Configuration Register (B5H/85H)

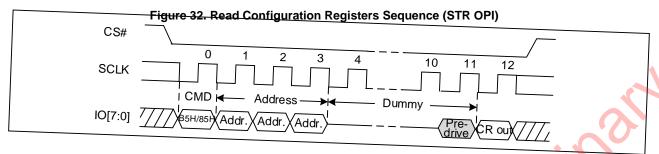
The Nonvolatile/Volatile Configuration Register command is for reading the Nonvolatile/Volatile Configuration Registers. It is followed by a 3-byte address (A23-A0) or a 4-byte address (A31-A0) and a dummy byte, and each bit is latched-in on the rising edge of SCLK. Then the Configuration Register, at that address, is shifted out on SO, and each bit is shifted out, at a Max frequency fC, on the falling edge of SCLK. Read Nonvolatile/Volatile Configuration Register command, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

CS# 28 29 30 31 **SCLK** 24-bit address Command SI B5H/85H High-Z SO CS# 32 33 34 35 36 37 38 39 40 41 42 43 44 45 46 47 **SCLK** 0 SI CR out (4)(3)SO

Figure 31. Read Configuration Registers Sequence Diagram (SPI)

Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.





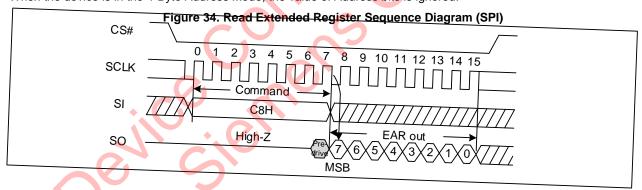
CS# 0 1 2 3 10 **SCLK** Dummy **←**Command**→**l Addr. Addr. Addr Addr. Pre-drive IO[7:0] B5H/85H

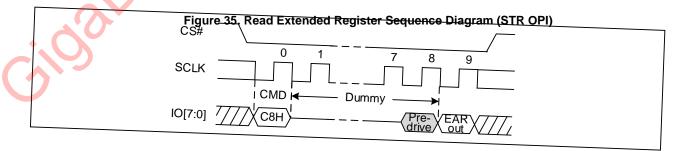
Figure 33. Read Configuration Registers Sequence (DTR OPI)

## 9.12. Read Extended Register (C8H)

Extended Register contains ECC Status Bit and Address Bits. The Read Extended Register instruction is entered by driving CS# low and shifting the instruction code "C8H" into the SI pin on the rising edge of SCLK. The Extended Register bits are then shifted out on the SO pin at the falling edge of SCLK with most significant bit (MSB) first.

When the device is in the 4-Byte Address Mode, the value of Address bits is ignored.







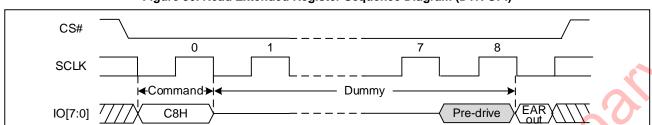


Figure 36. Read Extended Register Sequence Diagram (DTR OPI)

### 9.13. Read Data Bytes (READ) (03H/13H)

The Read Data Bytes (READ) command is followed by a 3-byte address (A23-A0) or a 4-byte address (A31-A0), and each bit is latched-in on the rising edge of SCLK. Then the memory content, at that address, is shifted out on SO, and each bit is shifted out, at a Max frequency fR, on the falling edge of SCLK. The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. The whole memory can, therefore, be read with a single Read Data Bytes (READ) command. Any Read Data Bytes (READ) command, while an Erase, Program or Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

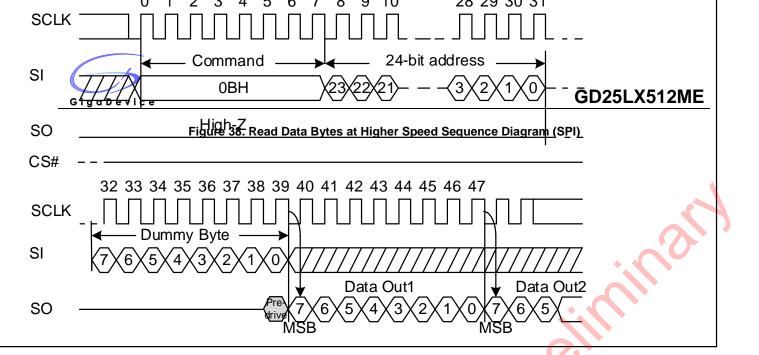
CS# 3 7 8 9 10 28 29 30 31 32 33 34 35 36 37 38 39 **SCLK** 24-bit address Command SI 03H Data Out1 Data Out2 **MSB** High-Z SO 4

Figure 37. Read Data Bytes Sequence Diagram

Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

## 9.14. Read Data Bytes at Higher Speed (Fast Read) (0BH/0CH)

The Read Data Bytes at Higher Speed (Fast Read) command is for quickly reading data out. It is followed by a 3-byte address (A23-A0) or a 4-byte address (A31-A0) and dummy clocks, and each bit is latched-in on the rising edge of SCLK. Then the memory content, at that address, is shifted out on SO, and each bit is shifted out, at a Max frequency fc, on the falling edge of SCLK. The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out.



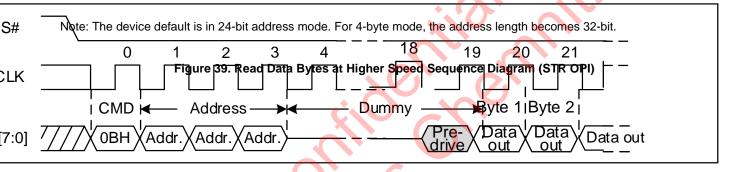
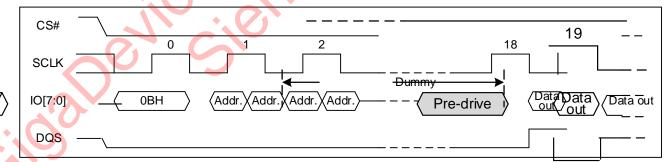


Figure 40. Read Data Bytes at Higher Speed Sequence Diagram (DTR OPI)



### 9.15. Octal Output Fast Read (8BH/7CH)

The Octal Output Fast Read command is followed by 3-byte address (A23-A0) or a 4-byte address (A31-A0) and dummy clocks, and each bit is latched in on the rising edge of SCLK, then the memory contents are shifted out 8-bit per clock cycle from IO7, IO6, IO5, IO4, IO3, IO2, IO1 and IO0. The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out.



Figure 41. Octal Output Fast Read Sequence Diagram (SPI)

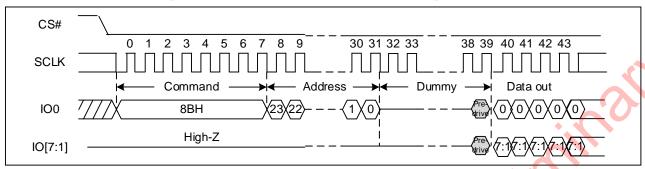
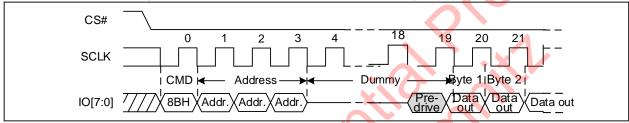
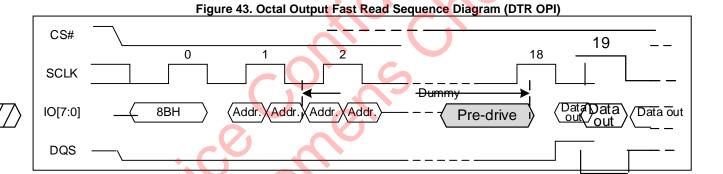


Figure 42. Octal Output Fast Read Sequence Diagram (STR OPI)



Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

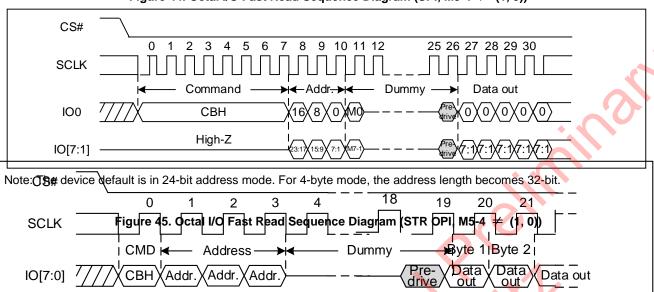


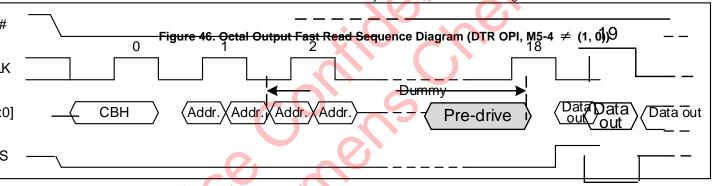
# 9.16. Octal I/O Fast Read (CBH/CCH)

The Octal I/O Fast Read command is similar to the Octal Output Fast Read command but with the capability to input the 3-byte address (A23-0) or a 4-byte address (A31-A0) and a "Continuous Read Mode" byte and dummy clocks. 8-bit per clock is transferred by IO[7:0] and each bit is latched in on the rising edge of SCLK, then the memory contents are shifted out 4-bit per clock cycle from IO[7:0]. The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out.



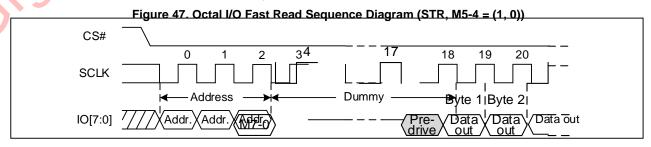
Figure 44. Octal I/O Fast Read Sequence Diagram (SPI, M5-4 ≠ (1, 0))





#### Octal I/O Fast Read with "Continuous Read Mode"

The Octal I/O Fast Read command can further reduce command overhead through setting the "Continuous Read Mode" bits (M7-0) after the input 3-byte address (A23-A0) or a 4-byte address (A31-A0). If the "Continuous Read Mode" bits (M5-4) = (1, 0), then the next Octal I/O Fast Read command (after CS# is raised and then lowered) does not require the CBH/CCH command code. If the "Continuous Read Mode" bits (M5-4) do not equal to (1, 0), the next command requires the first CBH/CCH command code, thus returning to normal operation.



Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.



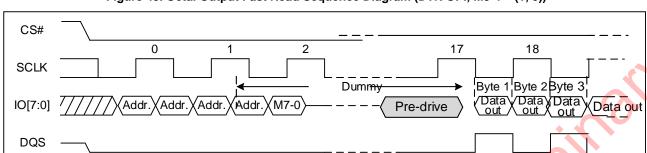


Figure 48. Octal Output Fast Read Sequence Diagram (DTR OPI, M5-4 = (1, 0))

## Octal I/O Fast Read with "16/32/64-Byte Wrap Around"

The Octal I/O Fast Read command can be used to access a specific portion within a page by issuing Wrap configuration register byte prior to CBH/CCH. The data being accessed can be limited to either a 16/32/64-byte section of a 256-byte page. The output data starts at the initial address specified in the command, once it reaches the ending boundary of the 16/32/64-byte section, the output will wrap around the beginning boundary automatically until CS# is pulled high to terminate the command.

The Burst with Wrap feature allows applications that use cache to quickly fetch a critical address and then fill the cache afterwards within a fixed length (16/32/64-byte) of data without issuing multiple read commands.

### 9.17. Octal I/O DTR Read (FDH)

The Octal I/O DTR Read command enables Double Transfer Rate throughput on Octal I/O of Serial Flash in read mode. The address (interleave on 8 I/O pins) is latched on both rising and falling edge of SCLK, and data (interleave on 8 I/O pins) shift out on both rising and falling edge of SCLK. The 8-bit address can be latched-in at one clock edge, and 8-bit data can be read out at one clock edge, which means 8 bits at rising edge of clock, the other 8 bits at falling edge of clock. The first address Byte can be at any location. The address is automatically increased to the next higher address after each Byte data is shifted out, so the whole memory can be read out at a single Octal I/O DTR Read command. The address counter rolls over to 0 when the highest address has been reached. Once writing Octal I/O DTR Read command, the following address/dummy/data out will perform as 8-bit instead of previous 1-bit.

While Program/Erase/Write Status Register cycle is in progress, DTROIO instruction is rejected without any impact on the Program/Erase/Write Status Register current cycle.



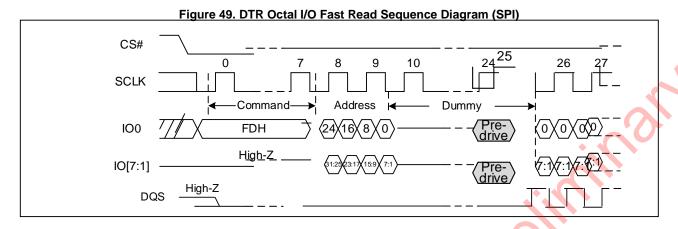
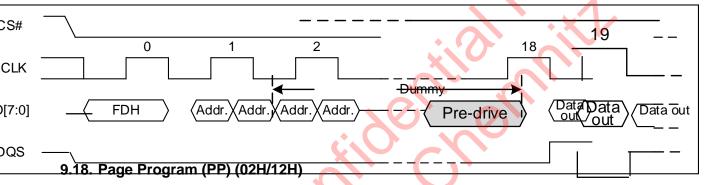


Figure 50. Octal Output Fast Read Sequence Diagram (OPI)



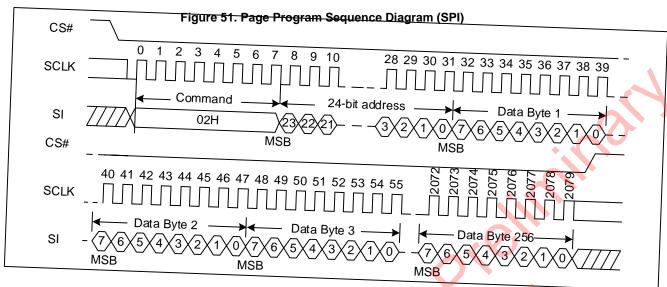
The Page Program (PP) command is for programming the memory. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Page Program command.

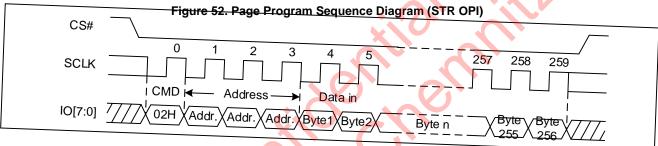
The Page Program (PP) command is entered by driving CS# Low, followed by the command code, three address bytes and at least one data byte on SI. If the 8 least significant address bits (A7-A0) are not all zero, all transmitted data that goes beyond the end of the current page are programmed from the start address of the same page (from the address whose 8 least significant bits (A7-A0) are all zero). CS# must be driven low for the entire duration of the sequence. The Page Program command sequence: CS# goes low  $\rightarrow$  sending Page Program command  $\rightarrow$  3-byte address or 4-byte address on SI  $\rightarrow$  at least 1 byte data on SI  $\rightarrow$  CS# goes high. If more than 256 bytes are sent to the device, previously latched data are discarded and the last 256 data bytes are guaranteed to be programmed correctly within the same page. If less than 256 data bytes are sent to device, they are correctly programmed at the requested addresses without having any effects on the other bytes of the same page. CS# must be driven high after the eighth bit of the last data byte has been latched in; otherwise the Page Program (PP) command is not executed.

As soon as CS# is driven high, the self-timed Page Program cycle (whose duration is t<sub>PP</sub>) is initiated. While the Page Program cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Page Program cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Page Program (PP) command applied to a page which is protected by the Block Protect (TB, BP3, BP2, BP1, and BP0) is not executed.







Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

CS#

0 1 2 3

SCLK

Command→ Address Data in

IO[7:0]

Addr. \( Addr. \( Addr. \) \( Addr. \) \( Addr. \) \( Addr. \) \( Byte 1 \) \( Byte 1 \) \( Byte n \) \( 256 \) \( \) \( \)

Figure 53. Page Program Sequence Diagram (DTR OPI)

### 9.19. Octal Page Program (82H/84H)

The Octal Page Program command is for programming the memory using four pins: IO0, IO1, IO2, IO3, IO4, IO5, IO6 and IO7. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Page Program command. The Octal Page Program command is entered by driving CS# Low, followed by the command code (82H/84H), three or four address bytes and at least one data byte on IO pins.

If more than 256 bytes are sent to the device, previously latched data are discarded and the last 256 data bytes are guaranteed to be programmed correctly within the same page. If less than 256 data bytes are sent to device, they are correctly programmed at the requested addresses without having any effects on the other bytes of the same page. CS# must be driven high after the eighth bit of the last data byte has been latched in; otherwise the Octal Page Program (PP) command is not executed.

As soon as CS# is driven high, the self-timed Octal Page Program cycle (whose duration is tpp) is initiated. While the Octal Page Program cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit.

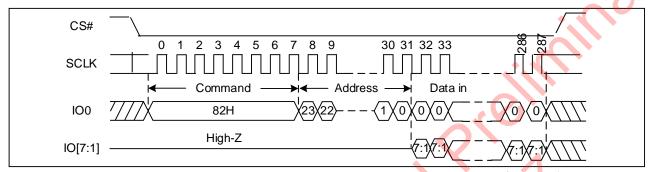


The Write in Progress (WIP) bit is 1 during the self-timed Octal Page Program cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

A Octal Page Program command applied to a page which is protected by the Block Protect (TB, BP3, BP1, and BP0) is not executed.

In DTR mode, the starting address given must be even (A0=0) and data byte number must be even

Figure 54. Octal Page Program Sequence Diagram (SPI)



Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

Figure 55. Page Program Sequence Diagram (STR OPI)

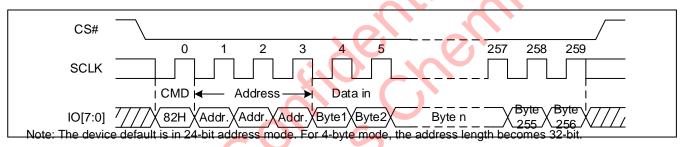
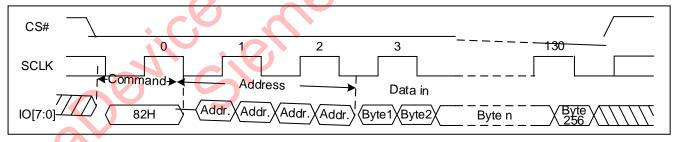


Figure 56. Page Program Sequence Diagram (DTR OPI)



### 9.20. Extend Octal Page Program (C2H/8EH)

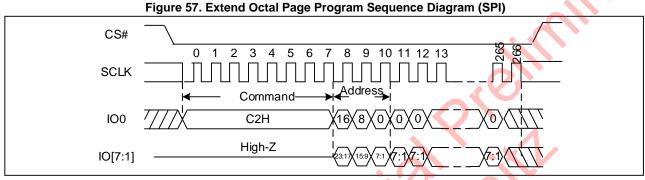
The Extend Octal Page Program command is for programming the memory using eight pins: IO0, IO1, IO2, IO3, IO4, IO5, IO6 and IO7. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Page Program command. The extend Octal Page Program command is entered by driving CS# Low, followed by the command code (C2H/8EH), three or four address bytes and at least one data byte on IO pins.

If more than 256 bytes are sent to the device, previously latched data are discarded and the last 256 data bytes are guaranteed to be programmed correctly within the same page. If less than 256 data bytes are sent to device, they are correctly programmed at the requested addresses without having any effects on the other bytes of the same page. CS# must be driven high after the eighth bit of the last data byte has been latched in; otherwise the Extend Octal Page Program (EPP) command is not executed.



As soon as CS# is driven high, the self-timed Extend Octal Page Program cycle (whose duration is tPP) is initiated. While the Extend Octal Page Program cycle is in progress, the Status Register may be read to check the value of the Write In Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Extend Octal Page Program cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. An Extend Octal Page Program command applied to a page which is protected by the Block Protect (TB, BP3, BP2, BP1, and BP0) is not executed.

In DTR mode, the starting address given must be even (A0=0) and data byte number must be even.



Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

CS#

O 1 2 3 4 5 257 258 259

SCLK

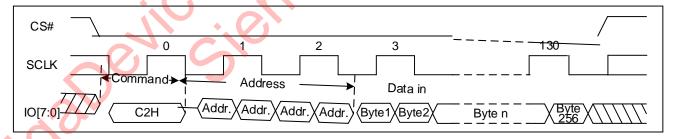
I CMD I Address Data in

IO[7:0] /// C2H Addr. Addr. Addr. Byte 1 Byte 2 Byte n Byte n Byte 255 256

Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

Figure 58. Page Program Sequence Diagram (STR OPI)



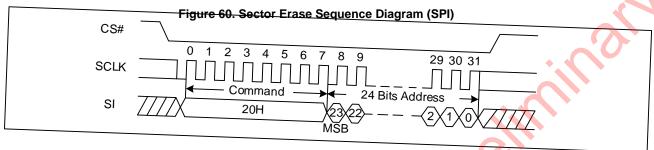


### 9.21. Sector Erase (SE) (20H/21H)

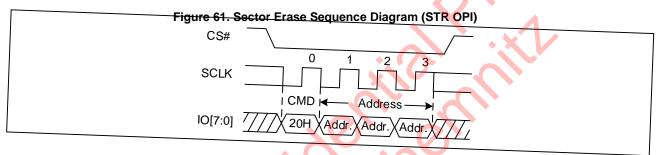
The Sector Erase (SE) command is erased the all data of the chosen sector. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit. The Sector Erase (SE) command is entered by driving CS# low, followed by the command code, and 3- byte address or 4-byte address on SI. Any address inside the sector is a valid address for the Sector Erase (SE) command. CS# must be driven low for the entire duration of the sequence. The Sector Erase command sequence: CS# goes low  $\rightarrow$  sending Sector Erase command  $\rightarrow$  3-byte address or 4-byte address on SI  $\rightarrow$  CS# goes high. CS# must be driven high after the eighth bit of the last address byte has been latched in; otherwise the Sector Erase (SE) command is not executed. As soon as CS# is driven high, the self-timed Sector Erase cycle (whose duration is  $t_{SE}$ ) is initiated. While the Sector Erase cycle is in progress, the Status Register may be read to



check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Sector Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. A Sector Erase (SE) command applied to a sector which is protected by the Block Protect (TB, BP3, BP2, BP1, and BP0) bit is not executed.



Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.



Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

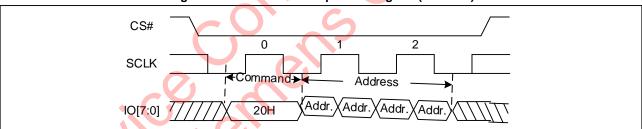


Figure 62. Sector Erase Sequence Diagram (DTR OPI)

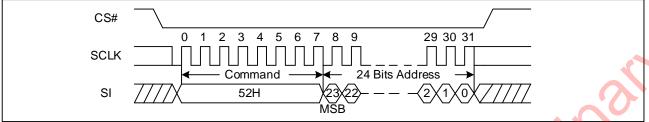
## 9.22. 32KB Block Erase (BE) (52H/5CH)

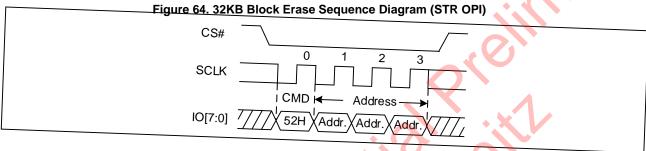
The 32KB Block Erase (BE) command is erased the all data of the chosen block. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit. The 32KB Block Erase (BE) command is entered by driving CS# low, followed by the command code, and 3-byte address or 4-byte address on SI. Any address inside the block is a valid address for the 32KB Block Erase (BE) command. CS# must be driven low for the entire duration of the sequence.

The 32KB Block Erase command sequence: CS# goes low  $\rightarrow$  sending 32KB Block Erase command  $\rightarrow$  3-byte address or 4-byte address on SI  $\rightarrow$  CS# goes high. CS# must be driven high after the eighth bit of the last address byte has been latched in; otherwise the 32KB Block Erase (BE) command is not executed. As soon as CS# is driven high, the self-timed Block Erase cycle (whose duration is  $t_{SE}$ ) is initiated. While the Block Erase cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Block Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. A 32KB Block Erase (BE) command applied to a block which is protected by the Block Protect (TB, BP3, BP2, BP1, and BP0) bits is not executed.



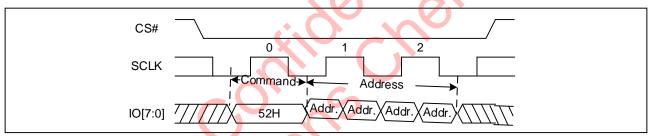






Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

Figure 65. 32KB Block Erase Sequence Diagram (DTR OPI)

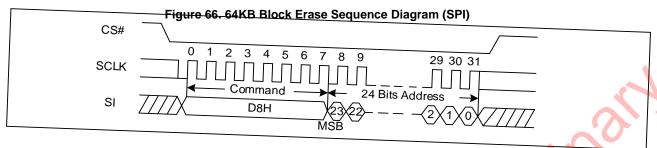


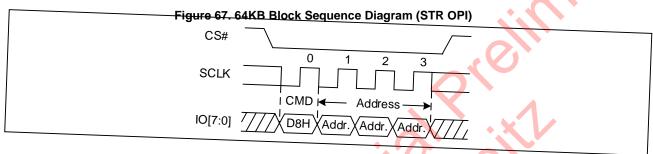
### 9.23. 64KB Block Erase (BE) (D8H/DCH)

The 64KB Block Erase (BE) command is erased the all data of the chosen block. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit. The 64KB Block Erase (BE) command is entered by driving CS# low, followed by the command code, and 3-byte address or 4-byte address on SI. Any address inside the block is a valid address for the 64KB Block Erase (BE) command. CS# must be driven low for the entire duration of the sequence.

The 64KB Block Erase command sequence: CS# goes low → sending 64KB Block Erase command → 3-byte address or 4-byte address on SI → CS# goes high. The command sequence is shown below. CS# must be driven high after the eighth bit of the last address byte has been latched in; otherwise the 64KB Block Erase (BE) command is not executed. As soon as CS# is driven high, the self-timed Block Erase cycle (whose duration is tsE) is initiated. While the Block Erase cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Block Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. A 64KB Block Erase (BE) command applied to a block which is protected by the Block Protect (TB, BP3, BP2, BP1, and BP0) bits is not executed.







Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

CS#

O
1
2
SCLK

Address

IO[7:0] 

D8H

Addr. Addr.

Figure 68. 64KB Block Sequence Diagram (DTR OPI)

### 9.24. Chip Erase (CE) (60/C7H)

The Chip Erase (CE) command is erased the all data of the chip. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit .The Chip Erase (CE) command is entered by driving CS# Low, followed by the command code on Serial Data Input (SI). CS# must be driven Low for the entire duration of the sequence. The Chip Erase command sequence: CS# goes low → sending Chip Erase command → CS# goes high. CS# must be driven high after the eighth bit of the command code has been latched in; otherwise the Chip Erase command is not executed. As soon as CS# is driven high, the self-timed Chip Erase cycle (whose duration is tcE) is initiated. While the Chip Erase cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Chip Erase cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. The Chip Erase (CE) command is executed if the Block Protect (BP2, BP1, and BP0) bits are 0 The Chip Erase (CE) command is ignored if one or more sectors are protected.

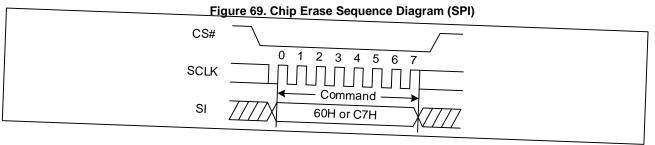
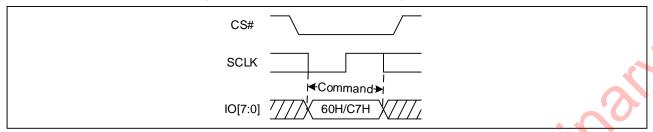




Figure 70. Chip Erase Sequence Diagram (OPI)



#### 9.25. Clear SR Flags (30H)

The Clear Status Register Flags command resets bit FS1 (Protection), FS4 (Program Error bit) and FS5 (Erase Error bit) from status register. It is not necessary to set the WEL bit before the Clear Status Register command is executed. The Clear SR command will be not accepted even when the device remains busy with WIP set to 1, as the device does remain busy when either error bit is set. The WEL bit will be unchanged after this command is executed.

Figure 71.Clear Status Register Flags Sequence Diagram (SPI)

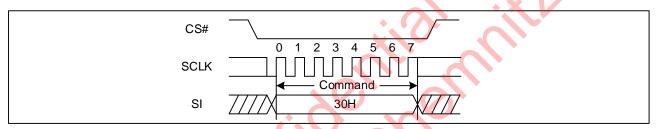
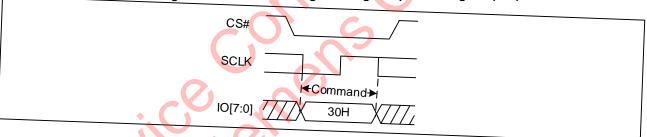


Figure 72. Clear Status Register Flags Sequence Diagram (OPI)



### 9.26. Deep Power-Down (DP) (B9H)

Executing the Deep Power-Down (DP) command is the only way to put the device in the lowest consumption mode (the Deep Power-Down Mode). It can also be used as an extra software protection mechanism, while the device is not in active use, since in this mode, the device ignores all Write, Program and Erase commands. Driving CS# high deselects the device, and puts the device in the Standby Mode (if there is no internal cycle currently in progress). But this mode is not the Deep Power-Down Mode. The Deep Power-Down Mode can only be entered by executing the Deep Power-Down (DP) command. Once the device has entered the Deep Power-Down Mode, all commands are ignored except the Release from Deep Power-Down (ABH) or Enable Reset (66H) and Reset (99H) commands. These commands can release the device from this mode. The Release from Deep Power-Down command releases the device from deep power down mode.

The Deep Power-Down Mode automatically stops at Power-Down, and the device is in the Standby Mode after Power-Up. The Deep Power-Down command sequence: CS# goes low → sending Deep Power-Down command → CS# goes high. CS# must be driven high after the eighth bit of the command code has been latched in; otherwise the Deep Power-Down (DP) command is not executed. As soon as CS# is driven high, it requires a delay of t<sub>DP</sub> before the supply current is reduced to I<sub>CC2</sub> and the Deep Power-Down Mode is entered. Any Deep Power-Down (DP) command, while an Erase, Program or



Write cycle is in progress, is rejected without having any effects on the cycle that is in progress.

Figure 73. Deep Power-Down Sequence Diagram (SPI)

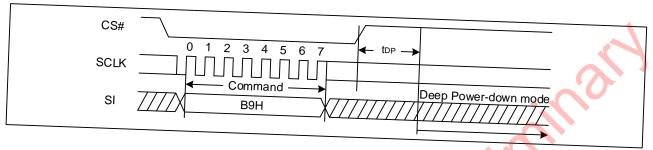
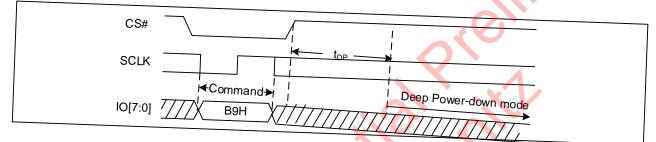


Figure 74. Deep Power-Down Sequence Diagram (OPI)



#### 9.27. Release from Deep Power-Down (ABH)

To release the device from the Power-Down state, the command is issued by driving the CS# pin low, shifting the instruction code "ABH" and driving CS# high. Release from Power-Down will take the time duration of t<sub>RES1</sub> (See AC Characteristics) before the device will resume normal operation and other command are accepted. The CS# pin must remain high during the t<sub>RES1</sub> time duration.

When used to release the device from the Power-Down state, the command is the same as previously described, After this time duration the device will resume normal operation and other command will be accepted. If the Release from Power-Down command is issued while an Erase, Program or Write cycle is in process (when WIP equal 1) the command is ignored and will not have any effects on the current cycle.

Figure 75. Release Power-Down Sequence Diagram (SPI)

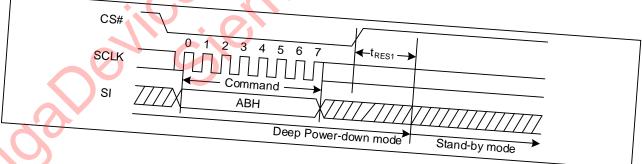
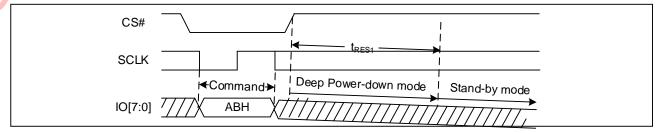


Figure 76. Release Power-Down Sequence Diagram (OPI)





### 9.28. Read Unique ID (4BH)

The Read Unique ID command accesses a factory-set read-only 128bit number that is unique to each device. The Unique ID can be used in conjunction with user software methods to help prevent copying or cloning of a system.

The Read Unique ID command sequence: CS# goes low  $\rightarrow$  sending Read Unique ID command  $\rightarrow$  3-byte address (0000000H) or 4-byte address (00000000H) on SI  $\rightarrow$ 1 Byte Dummy  $\rightarrow$ 128bit Unique ID Out  $\rightarrow$ CS# goes high.

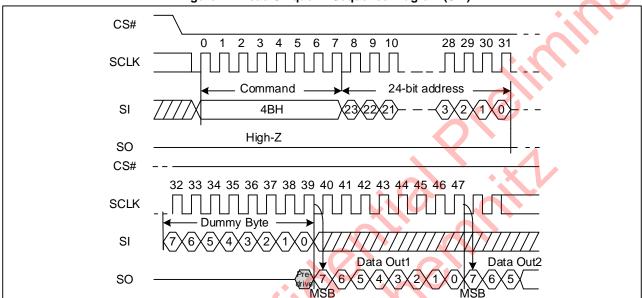


Figure 77. Read Unique ID Sequence Diagram (SPI)

Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

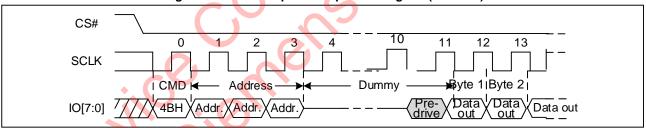


Figure 78. Read Unique ID Sequence Diagram (STR OPI)

Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

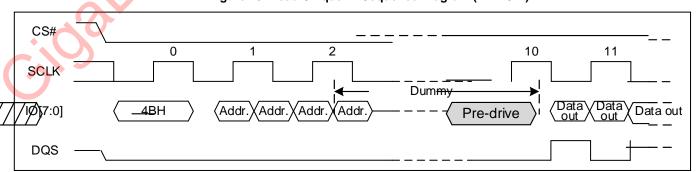


Figure 79. Read Unique ID Sequence Diagram (DTR OPI)

### 9.29. Read Identification (RDID) (9FH/9EH)

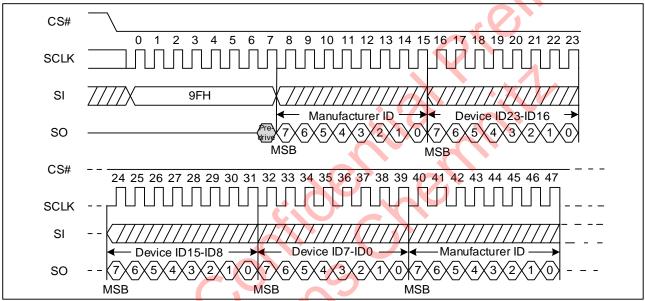
The Read Identification (RDID) command allows the 8-bit manufacturer identification to be read, followed by 3-bytes of



device identification. The ID will cycle 4 times. The device identification indicates the memory type in the first byte, and the memory capacity of the device in the second byte. The Read Identification (RDID) command while an Erase or Program cycle is in progress, is not decoded, and has no effect on the cycle that is in progress. The Read Identification (RDID) command should not be issued while the device is in Deep Power-Down Mode.

The device is first selected by driving CS# low. Then, the 8-bit command code for the command is shifted in. This is followed by the 24-bit device identification, stored in the memory. Each bit is shifted out on the falling edge of Serial Clock. The command sequence is shown below. The Read Identification (RDID) command is terminated by driving CS# high at any time during data output. When CS# is driven high, the device is in the Standby Mode. Once in the Standby Mode, the device waits to be selected, so that it can receive, decode and execute commands.

Figure 80. Read Identification ID Sequence Diagram (SPI)



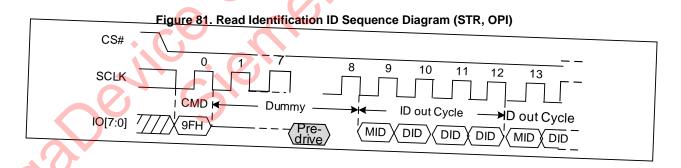
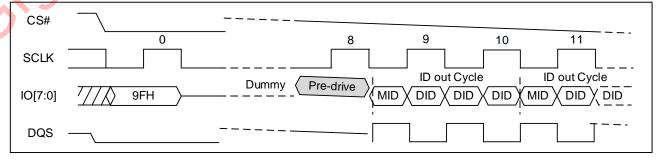


Figure 82. Read Identification ID Sequence Diagram (DTR, OPI)





## 9.30. Program/Erase Suspend (PES) (75H)

The Program/Erase Suspend command "75H", allows the system to interrupt a page program or sector/block erase operation and then read data from any other sector or block. The Write Register command (01H/B1H) and Erase/Program Security Registers command (44H,42H) and Erase commands (20H, 52H, D8H, C7H, 60H) and Page Program command (02H/82H/C2H/84H/8EH) are not allowed during Program suspend. The Write Register command (01H/B1H) and Erase Security Registers command (44H) and Erase commands (20H, 52H, D8H, C7H, 60H) are not allowed during Erase suspend. Program/Erase Suspend is valid only during the page program or sector/block erase operation. A maximum of time of "tsus" (See AC Characteristics) is required to suspend the program/erase operation.

The Program/Erase Suspend command will be accepted by the device only if the SUS\_E/SUS\_P bit in the Status Register equal to 0 and WIP bit equal to 1 while a Page Program or a Sector or Block Erase operation is on-going. If the SUS\_E/SUS\_P bit equal to 1 or WIP bit equal to 0, the Suspend command will be ignored by the device. The WIP bit will be cleared from 1 to 0 within "tsus" and the SUS\_E/SUS\_P bit will be set from 0 to 1 immediately after Program/Erase Suspend. A power-off during the suspend period will reset the device and release the suspend state.

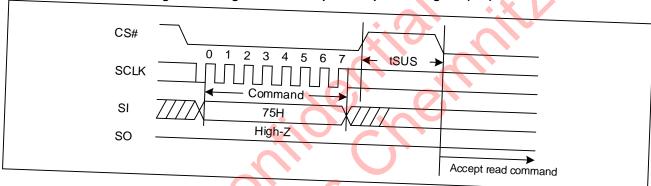
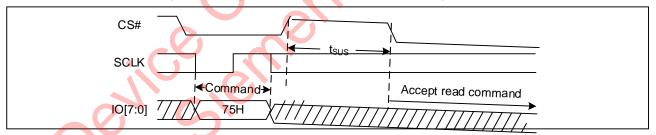


Figure 83. Program/Erase Suspend Sequence Diagram (SPI)

Figure 84. Program/Erase Suspend Sequence Diagram (OPI)



# 9.31. Program/Erase Resume (PER) (7AH)

The Program/Erase Resume command must be written to resume the program or sector/block erase operation after a Program/Erase Suspend command. The Program/Erase Resume command will be accepted by the device only if the SUS2/SUS1 bit equal to 1 and the WIP bit equal to 0. After issued the SUS2/SUS1 bit in the status register will be cleared from 1 to 0 immediately, the WIP bit will be set from 0 to 1 within 200ns and the Sector or Block will complete the erase operation or the page will complete the program operation. The Program/Erase Resume command will be ignored unless a Program/Erase Suspend is active.





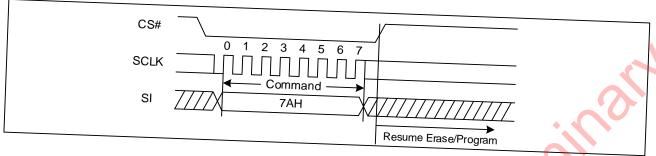
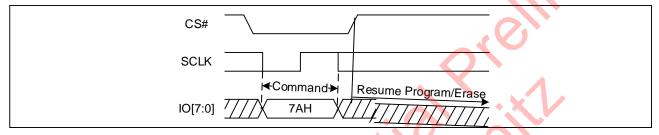


Figure 86. Program/Erase Resume Sequence Diagram (OPI)



### 9.32. Erase Security Registers (44H)

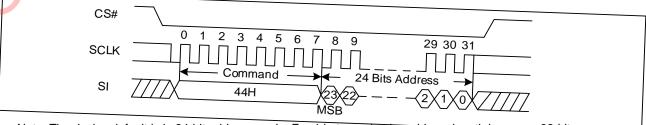
The GD25LX512ME provides 4K-Byte Security Registers which can be erased and programmed individually. These registers may be used by the system manufacturers to store security and other important information separately from the main memory array.

The Erase Security Registers command is similar to Sector/Block Erase command. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit.

The Erase Security Registers command sequence: CS# goes low → sending Erase Security Registers command → CS# goes high. CS# must be driven high after the eighth bit of the last address byte has been latched in; otherwise the Erase Security Registers command is not executed. As soon as CS# is driven high, the self-timed Erase Security Registers cycle (whose duration is tse) is initiated. While the Erase Security Registers cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Erase Security Registers cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset. The Security Registers Lock Bit in the Configuration Register can be used to OTP protect the security registers. Once the bit is set to 1, the Security Registers will be permanently locked; the Erase Security Registers command will be ignored.

Address	A23-16	A15-12	A11-8	A7-0
Security Register	00H	0000	Page Address	Byte Address

Figure 87. Erase Security Registers command Sequence Diagram (SPI)



Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit



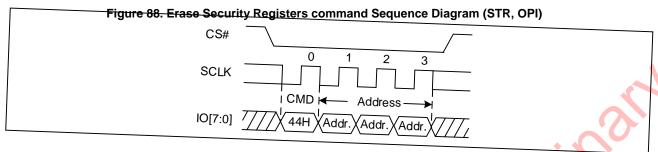
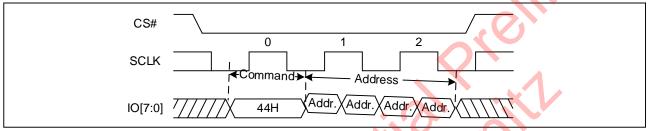


Figure 89. Erase Security Registers command Sequence Diagram (DTR, OPI)



### 9.33. Program Security Registers (42H)

The Program Security Registers command is similar to the Page Program command. Each security register contains four pages content. A Write Enable (WREN) command must previously have been executed to set the Write Enable Latch (WEL) bit before sending the Program Security Registers command. The Program Security Registers command is entered by driving CS# Low, followed by the command code (42H), three address bytes and at least one data byte on SI. As soon as CS# is driven high, the self-timed Program Security Registers cycle (whose duration is tPP) is initiated. While the Program Security Registers cycle is in progress, the Status Register may be read to check the value of the Write in Progress (WIP) bit. The Write in Progress (WIP) bit is 1 during the self-timed Program Security Registers cycle, and is 0 when it is completed. At some unspecified time before the cycle is completed, the Write Enable Latch (WEL) bit is reset.

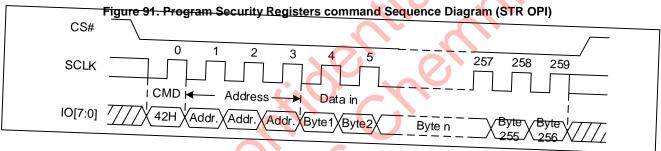
If the Security Registers Lock Bit is set to 1, the Security Registers will be permanently locked. Program Security Registers command will be ignored.

Address	A23-16	A15-12	A11-8	A7-0
Security Register	00H	0000	Page Address	Byte Address



CS# 9 10 28 29 30 31 32 33 34 35 36 37 38 39 2 3 8 **SCLK** 42H SI **MSB** CS# 40 41 42 43 44 45 46 47 48 49 50 51 52 53 54 55 **SCLK** SI MSB **MSB** MSB

Figure 90. Program Security Registers command Sequence Diagram (SPI)



Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

CS#

SCLK

Address

Data in

IO[7:0]

Addr. \( Addr. \) \( Addr. \) \( Addr. \) \( Byte1 \) \( Byte2 \) \( Byte n \) \( \frac{Byte}{256} \)

Figure 92. Program Security Registers command Sequence Diagram (DTR OPI)

### 9.34. Read Security Registers (48H)

The Read Security Registers command is similar to Fast Read command. The command is followed by a 3-byte address (A23-A0) and a dummy byte, and each bit is latched-in on the rising edge of SCLK. Then the memory content, at that address, is shifted out on SO, and each bit is shifted out, at a Max frequency fC, on the falling edge of SCLK. The first byte addressed can be at any location. The address is automatically incremented to the next higher address after each byte of data is shifted out. Once the A11-A0 address reaches the last byte of the register (Byte FFFH), it will reset to 000H, the command is completed by driving CS# high.

Address	A23-16	A15-12	A11-8	A7-0
Security Register	00H	0000	Page Address	Byte Address



CS#

O 1 2 3 4 5 6 7 8 9 10 28 29 30 31

SCLK

Command

C

Figure 93. Read Security Registers command Sequence Diagram (SPI)

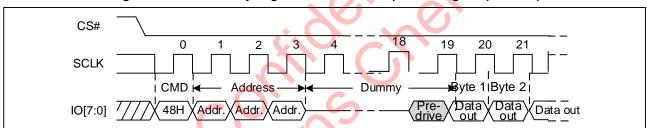


Figure 94. Read Security Registers command Sequence Diagram (STR OPI)

Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

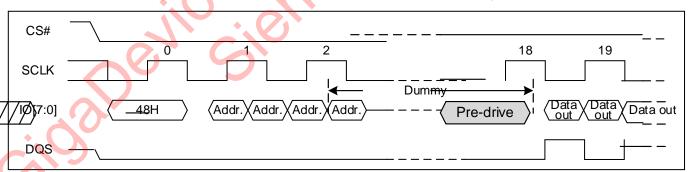


Figure 95. Read Security Registers command Sequence Diagram (DTR OPI)

## 9.35. Individual Block/Sector Lock (36H)/Unlock (39H)/Read (3DH)

The individual block/sector lock provides an alternative way to protect the memory array from adverse Erase/Program. In order to use the Individual Block/Sector Locks, the WPS bit in Configuration Register bit 2 at address 04h must be set to 0. If WPS=1, the write protection will be determined by the combination of TB, BP (3:0) bits in the Status Register.

The individual Block/Sector Lock command (36H) sequence: CS# goes low →SI: Sending individual Block/Sector Lock command → SI: Sending 24bits/32bits individual Block/Sector Lock Address → CS# goes high.

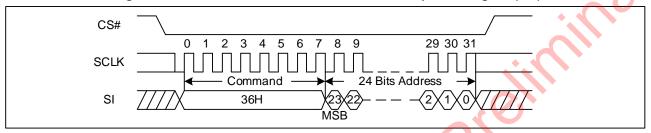
The individual Block/Sector Unlock command (39H) sequence: CS# goes low →SI: Sending individual Block/Sector Unlock



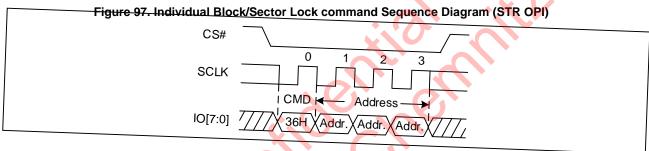
command→ SI: Sending 24bits/32bits individual Block/Sector Lock Address → CS# goes high.

The Read individual Block/Sector lock command (3DH) sequence: CS# goes low  $\rightarrow$  SI: Sending Read individual Block/Sector Lock command  $\rightarrow$  SI: Sending 24bits/32bits individual Block/Sector Lock Address  $\rightarrow$  SO: The Block/Sector Lock Bit will out  $\rightarrow$ CS# goes high. If the least significant bit (LSB) is1, the corresponding block/sector is locked, if the LSB is 0, the corresponding block/sector is unlocked, Erase/Program operation can be performed.

Figure 96. Individual Block/Sector Lock command Sequence Diagram (SPI)

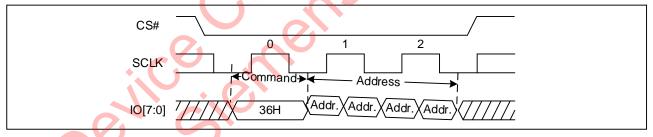


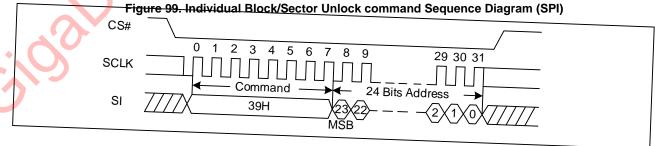
Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.



Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

Figure 98. Individual Block/Sector Lock command Sequence Diagram (DTR OPI)





Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.



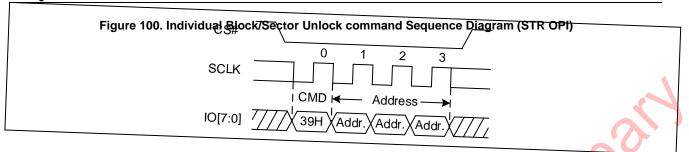
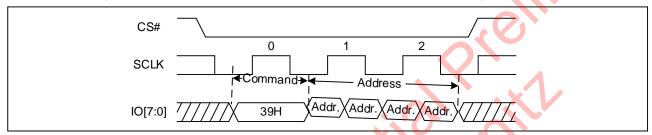
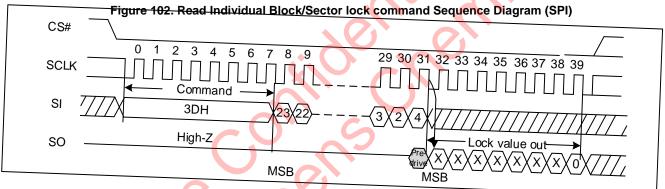


Figure 101. Individual Block/Sector Unlock command Sequence Diagram (DTR OPI)





Note: The device default is in 24-bit address mode. For 4-byte mode, the address length becomes 32-bit.

Figure 103. Read Individual Block/Sector lock command Sequence Diagram (STR OPI)

CS#

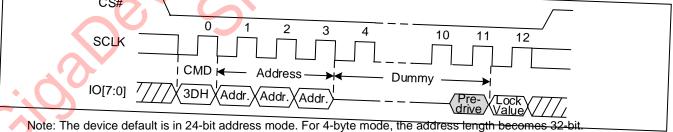
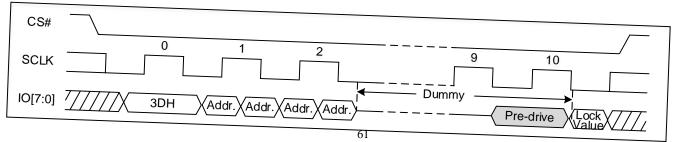


Figure 104. Read Individual Block/Sector lock command Sequence Diagram (DTR OPI)





### 9.36. Global Block/Sector Lock (7EH) or Unlock (98H)

All Block/Sector Lock bits can be set to 1 by the Global Block/Sector Lock command, or can set to 0 by the Global Block/Sector Unlock command.

The Global Block/Sector Lock command (7EH) sequence: CS# goes low →SI: Sending Global Block/Sector Lock command → CS# goes high.

The Global Block/Sector Unlock command (98H) sequence: CS# goes low →SI: Sending Global Block/Sector Unlock command → CS# goes high.

Figure 105. The Global Block/Sector Lock Sequence Diagram (SPI)

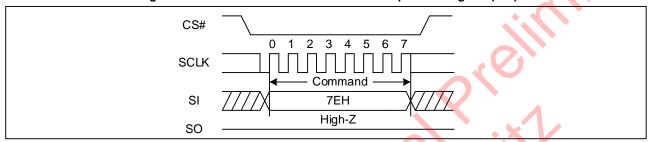


Figure 106. The Global Block/Sector Lock Sequence Diagram (OPI)

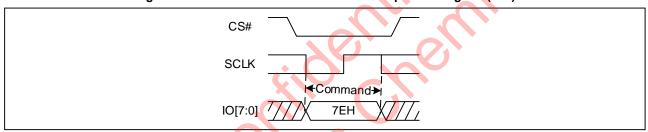


Figure 107. The Global Block/Sector Unlock Sequence Diagram (SPI)

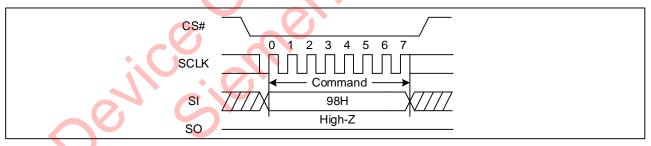
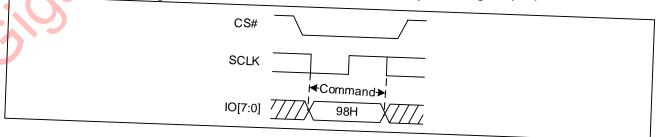


Figure 108. The Global Block/Sector Unlock Sequence Diagram (OPI)



## 9.37. Enable Reset (66H) and Reset (99H)

If the Reset command is accepted, any on-going internal operation will be terminated and the device will return to its default



power-on state and lose all the current volatile settings, such as Volatile Status Register bits, Write Enable Latch status (WEL), Program/Erase Suspend status, Read Parameter setting (P7-P0), Deep Power Down Mode, Continuous Read Mode bit setting (M7-M0).

When Flash is in OPI Mode, DTR Mode or Continuous Read Mode (XIP), 66H&99H cannot reset Flash to power-on state.

Therefore, it is recommended to send the following sequence to reset Flash in these modes:

- 1. 8CLK with IO<7:0>=all "H" or all "L": ensure Flash quit XIP mode
- 2. OPI format 66H/99H: ensure Flash in OPI mode and DTR mode can be reset
- 3. SPI format 66H/99H: ensure Flash in SPI mode can be reset

The "Enable Reset (66H)" and the "Reset (99H)" commands can be issued in either SPI or OPI mode. The "Reset (99H)" command sequence as follow: CS# goes low → Sending Enable Reset command → CS# goes high → CS# goes low → Sending Reset command → CS# goes high. Once the Reset command is accepted by the device, the device will take approximately tRST / tRST\_E to reset. During this period, no command will be accepted. Data corruption may happen if there is an on-going or suspended internal Erase or Program operation when Reset command sequence is accepted by the device. It is recommended to check the WIP bit and the SUS bit in Status Register before issuing the Reset command sequence.

Figure 109. Enable Reset and Reset command Sequence Diagram (SPI)

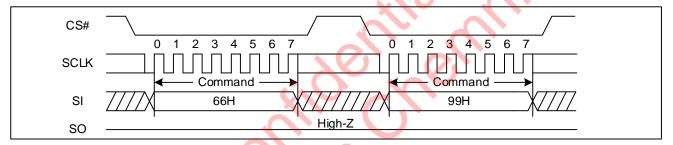
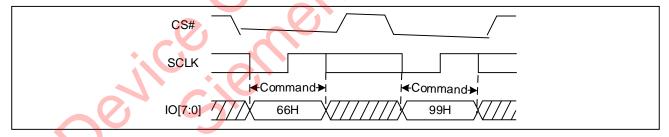


Figure 110. Enable Reset and Reset command Sequence Diagram (OPI)



#### 9.38. Read Serial Flash Discoverable Parameter (5AH)

The Serial Flash Discoverable Parameter (SFDP) standard provides a consistent method of describing the functional and feature capabilities of serial flash devices in a standard set of internal parameter tables. These parameter tables can be interrogated by host system software to enable adjustments needed to accommodate divergent features from multiple vendors. The concept is similar to the one found in the Introduction of JEDEC Standard, JESD68 on CFI. SFDP is a standard of JEDEC Standard No.216C.

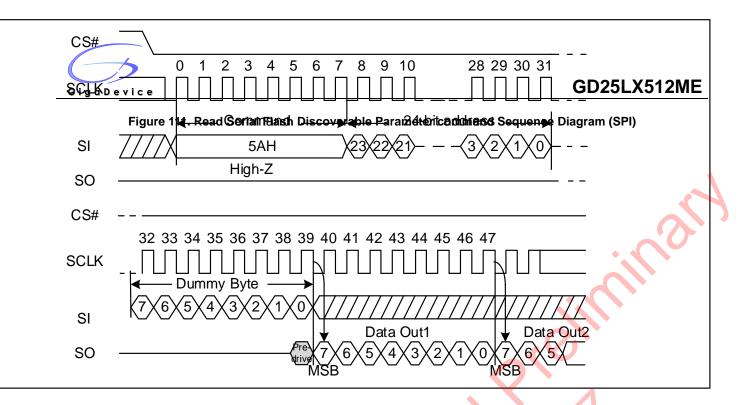


Figure 112. Read Serial Flash Discoverable Parameter command Sequence Diagram (STR OPI)

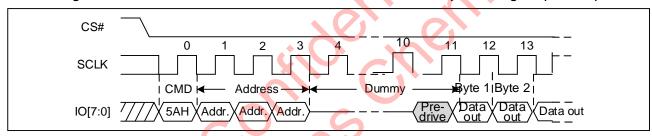


Figure 113. Read Serial Flash Discoverable Parameter command Sequence Diagram (DTR OPI)

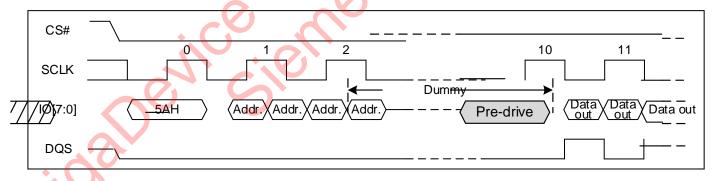


Table 5 Signature and Parameter Identification Data Values (Please contact GigaDevice for Details)



# 10. ELECTRICAL CHARACTERISTICS

## 10.1. Power-On Timing

Figure 114. Power-on Timing

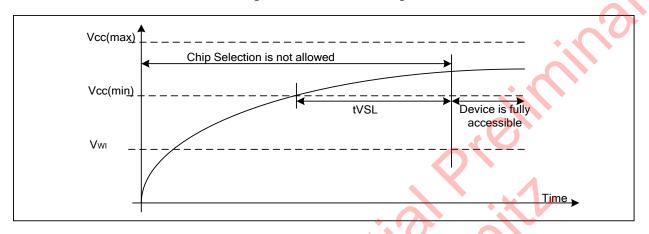


Table 16. Power-Up Timing and Write Inhibit Threshold

Symbol	Parameter		Min.	Max.	Unit
tVSL	VCC (min.) to device operation	70,00	2.5		ms
VWI	Write Inhibit Voltage		1	1.4	V

# 10.2. Initial Delivery State

The device is delivered with the memory array erased: all bits are set to 1(each byte contains FFH). The Status Register contains 00H (all Status Register bits are 0).

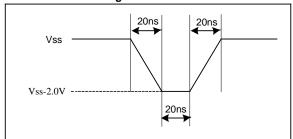
# 10.3. Absolute Maximum Ratings

Parameter	Value	Unit
Ambient Operating Temperature	-40 to 85	$^{\circ}\!\mathbb{C}$
Storage Temperature	-65 to 150	$^{\circ}$ C
Transient Input/Output Voltage (note: overshoot)	-2.0 to VCC+2.0	V
Applied Input/Output Voltage	-0.6 to VCC+0.4	V
VCC	-0.6 to 2.5	V

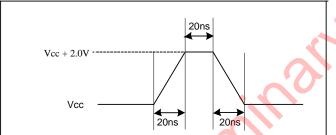


Figure 115. Input Test Waveform and Measurement Level

### **Maximum Negative Overshoot Waveform**



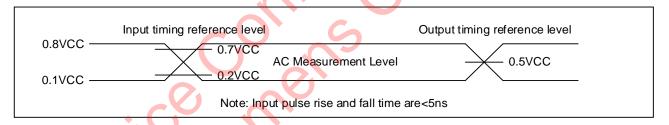
### **Maximum Positive Overshoot Waveform**



# 10.4. Capacitance Measurement Conditions

Symbol	Parameter	Min	Тур.	Max	Unit	Conditions
CIN	Input Capacitance			6	pF	VIN=0V
COUT	Output Capacitance			8	pF	VOUT=0V
CL	Load Capacitance		12		pF	
	Input Rise And Fall time	<b>5</b>	10	5	ns	
	Input Pause Voltage	0.1VCC	to 0.8VC	С	V	
	Input Timing Reference Voltage	0.2VC	C to 0.7V0	CC	V	
	Output Timing Reference Voltage		0.5VCC		V	

Figure 116. Input Test Waveform and Measurement Level





# 10.5. DC Characteristics

(T= -40  $^{\circ}\text{C} \sim 85 \,^{\circ}\text{C}$  , VCC=1.65 $\sim$ 2.0V)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Unit.
ILI	Input Leakage Current				±2	μA
ILO	Output Leakage Current				±2	μΑ
Icc1	Standby Current	CS#=VCC,		20	150	μA
		V <sub>IN</sub> =VCC or VSS				
I <sub>CC2</sub>	Deep Power-Down Current	CS#=VCC,		3	50	μΑ
		V <sub>IN</sub> =VCC or VSS				
		CLK=0.1VCC /				
		0.9VCC		35	50	mA
		at 200MHz,		33	30	IIIA
laas	Operating Current (Read)	Q=Open(*1,*4 I/O)			A	
I <sub>CC3</sub>	Operating Current (Neau)	CLK=0.1VCC /				
		0.9VCC		25	40	mA
		at 166MHz,		20	40	IIIA
		Q=Open(*1,*4 I/O)				
I <sub>CC4</sub>	Operating Current (PP)	CS#=VCC			40	mA
I <sub>CC5</sub>	Operating Current(WRSR)	CS#=VCC			40	mA
I <sub>CC6</sub>	Operating Current (SE)	CS#=VCC			40	mA
I <sub>CC7</sub>	Operating Current (BE)	CS#=VCC			40	mA
I <sub>CC8</sub>	Operating Current (CE)	CS#=VCC			40	mA
V <sub>IL</sub>	Input Low Voltage	0, 6	-0.5		0.2VCC	V
ViH	Input High Voltage		0.7VCC		VCC+0.4	V
VoL	Output Low Voltage	I <sub>OL</sub> =100uA			0.2	V
Voн	Output High Voltage	Іон =-100µА	VCC-0.2			V

## Note:

- 1. Typical value tested at T = 25°C. ◆
- 2. Value guaranteed by design and/or characterization, not 100% tested in production.



# 10.6. AC Characteristics

(T= -40°C~85°C, VCC=1.65~2.0V, C∟=30pf)

Symbol	Parar	neter	Min.	Тур.	Max.	Unit
f <sub>C1</sub>	Serial Clock Frequency for all in	structions except Read			166	MHz
f <sub>C2</sub>	Serial Clock Frequency for Fast	Read in DTR Mode (0BH, 0CH,			200	MHz
IC2	8BH, 7CH, CBH, CCH, FDH in	8BH, 7CH, CBH, CCH, FDH in DTR mode)			200	IVII IZ
f <sub>R</sub>	Serial Clock Frequency For: Re	Serial Clock Frequency For: Read (03H, 13H)			60	MHz
tclh	Serial Clock High Time	Serial Clock High Time				ns
toln .	ochar olook riigh riine		(1/fc)	1		113
t <sub>CLL</sub>	Serial Clock Low Time		45%			ns
-022			(1/fc)			
	Serial Clock Rise Time (Slew	fSCLK≤ 100MHz	0.6			V/ns
<b>t</b> CLCH	Rate)/Serial Clock Fall Time	fSCLK≤ 133MHz	0.8	1		V/ns
<b>t</b> CHCL	(Slew Rate)	fSCLK≤ 166MHz	1	. X		V/ns
	(Glow Hate)	fSCLK≥ 166MHz	1.2			V/ns
<b>t</b> slch	CS# Active Setup Time		4.5			ns
tснsн	CS# Active Hold Time		3			ns
tclsh	CS# Active Hold Time (DTR)		5			ns
tshch	CS# Not Active Setup Time		5			ns
tchsl	CS# Not Active Hold Time		5			ns
		From Read to next Read	20			ns
<b>t</b> shsl	CS# High Time (Read/Write)	From Write/Erase/Program to	40			ns
		Read Statue Register				110
$t_{CLQX}$	Output Hold Time		1			ns
tchqx			•			
tovch	Data In Setup Time (STR)	fSCLK ≤ 133MHz	2			ns
LD VOIT	Data in Cotap Time (CTT)	fSCLK > 133MHz	1			ns
		fSCLK ≤ 100MHz	1			ns
$t_{DVCH}$	Data In Setup Time (DTR)	fSCLK ≤ 133MHz	0.8			ns
tovcl	(2),	fSCLK ≤ 166MHz	0.6			ns
		fSCLK > 166MHz	0.5			ns
t <sub>CHDX</sub>	Data In Hold Time (STR)	fSCLK ≤ 133MHz	2			ns
CLIDA	Data irriola rimo (Orri)	fSCLK > 133MHz	1			ns
		fSCLK ≤ 100MHz	1			ns
tchdx	Data In Hold Time (DTR)	fSCLK ≤ 133MHz	0.8			ns
tcldx	Data in Fiold Time (DTK)	fSCLK ≤ 166MHz	0.6			ns
		fSCLK > 166MHz	0.5			ns
t <sub>SHQZ</sub>	Output Disable Time				8	ns
t <sub>QSV</sub>	Clock transient to DQS valid tim	ie	Aligr	to 30pF tC	LQV	ns
$t_{\text{DQSQ}}$	SIO valid skew related to DQS				1.2	ns
tqHs	SIO hold skew factor				1.2	ns





t <sub>CLQV</sub>	Clock Transient To Output Valid			8	ns
twhst	Write Protect Setup Time Before CS# Low	20			ns
tshwl	Write Protect Hold Time After CS# High	100			ns
t <sub>DP</sub>	CS# High To Deep Power-Down Mode			10	μs
t <sub>RES1</sub>	CS# High To Standby Mode			30	μs
t <sub>SUS</sub>	CS# High To Next Command After Suspend			20	μs
t <sub>RST</sub>	CS# High To Next Command After Reset (except from erase)			30	μs
trst_e	CS# High To Next Command After Reset (from erase)		• •	30	ms
4	Write Status Register Cycle Time			40	
t <sub>W</sub>	Write Non-Volatile Configuration Register Cycle Time		5	40	ms
t <sub>BP1</sub>	Byte Program Time (First Byte)		30	50	μs
t <sub>BP2</sub>	Additional Byte Program Time (After First Byte)		2.5	5	μs
t <sub>PP</sub>	Page Programming Time		0.15	1.0	ms
tse	Sector Erase Time		30	400	ms
t <sub>BE1</sub>	Block Erase Time(32K Bytes)		0.2	0.8	S
t <sub>BE2</sub>	Block Erase Time(64K Bytes)		0.22	2	S
tce	Chip Erase Time(GD25LX512ME)		150	300	S

#### Note:

- 1. Typical value tested at T =  $25^{\circ}$ C.
- 2. Value guaranteed by design and/or characterization, not 100% tested in production.
- 3. Time of CS# High To Next Command After Reset from 01H/B1H command would be tW + tRST



Figure 117. Serial Input Timing

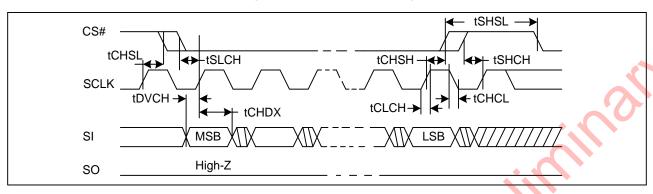


Figure 118. Output Timing

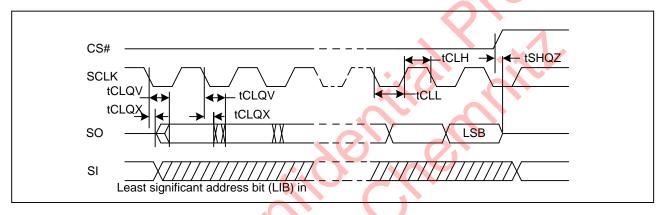
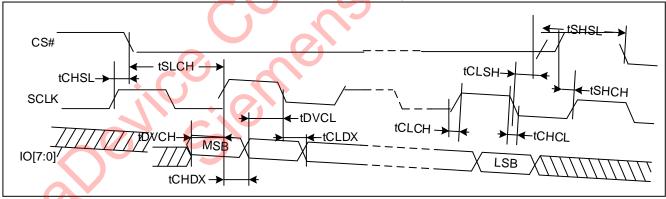


Figure 119. Serial Input Timing (DTR)



CS#

tCLQV
SCLK

IO[7:0]

MSB

tCHQX

TO



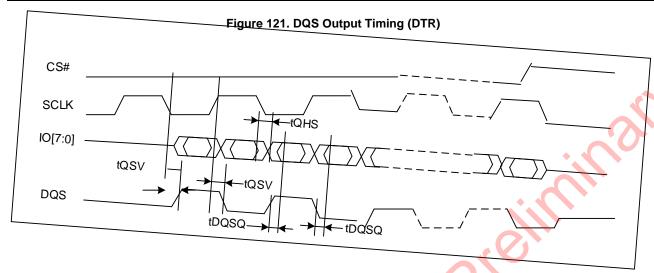


Figure 122. RESET Timing

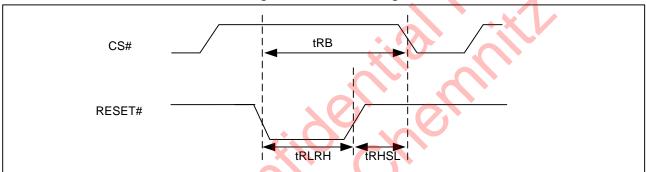


Table 17. Reset Timing

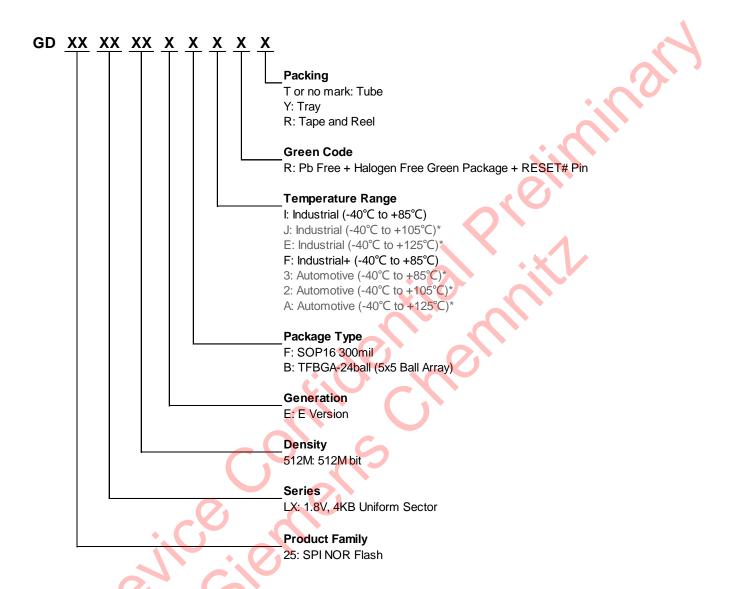
Symbol	Parameter	Min.	Тур.	Max.	Unit.
t <sub>RLRH</sub>	Reset Pulse Width	1			μs
trhsl	Reset High Time Before Read	50			ns
4	Reset Recovery Time (From Read or Program)			30	μs
t <sub>RB</sub>	Reset Recovery Time (From Erase)			30	ms

#### Note:

1. Time of Reset Recovery Time from 01H/B1H command would be tW + tRB



## 11. ORDERING INFORMATION



<sup>\*</sup>This datasheet applies to temperature range I: Industrial (-40°C to +85°C) and F: Industrial+ (-40°C to +85°C) only. Please contact GigaDevice sales for extended temperature industrial products and automotive products.



## 11.1. Valid Part Numbers

Please contact GigaDevice regional sales for the latest product selection and available form factors.

# Temperature Range I: Industrial (-40°C to +85°C)

Product Number	Density	Package Type
GD25LX512MEFIR	512Mbit	SOP16 300mil
GD25LX512MEBIR	512Mbit	TFBGA-24ball (5x5 Ball Array)

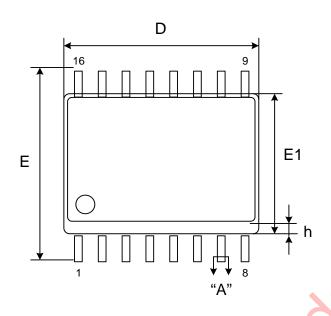
## Temperature Range F: Industrial+ (-40°C to +85°C)

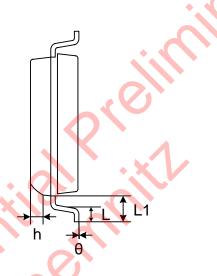
Product Number	Density	Package Type
GD25LX512MEFFR	512Mbit	SOP16 300mil
GD25LX512MEBFR	512Mbit	TFBGA-24ball (5x5 Ball Array)

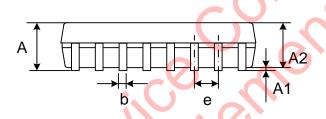


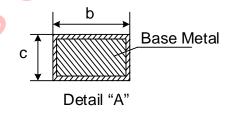
# 12. PACKAGE INFORMATION

# 12.1. Package SOP16 300MIL









# **Dimensions**

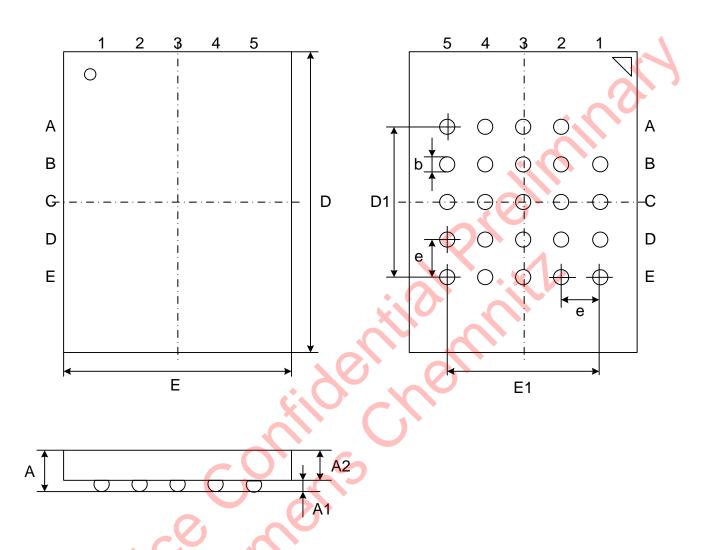
Sy	mbol	A	A1	A2	b	С	D	E	E1	е	L	L1	h	θ
L	Init	,												
A	Min	-	0.10	2.05	0.31	0.10	10.20	10.10	7.40	1.27	0.40		0.25	0
mm	Nom	-	0.20		0.41	0.25	10.30	10.30	7.50		-	-	1.40	ı
-	Max	2.65	0.30	2.55	0.51	0.33	10.40	10.50	7.60		1.27		0.75	8

### Note:

- 1. Both the package length and width do not include the mold flash.
- 2. Seating plane: Max. 0.1mm.



# 12.2. Package TFBGA-24BALL (5x5 ball array)



# **Dimensions**

	mbol Jnit	Α	<b>A</b> 1	A2	b	E	E1	D	D1	е	
	Min	-	0.25	0.75	0.35	5.90	4.00	7.90			
mm	Nom	-	0.30	0.80	0.40	6.00		4.00 8.00	8.00	4.00	1.00
	Max	1.20	0.35	0.85	0.45	6.10		8.10			

Note: Both the package length and width do not include the mold flash.



# 13. REVISION HISTORY

Version No	Description	Page	Date
0.1	Preliminary release	All	2019-6-18



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